

## Certificate of non-use of The Controlled Substances

Company name           Littelfuse, LP (Subsidiary of Littelfuse, Inc.)

Product Covered        Thyristor TO-220 L Package (Isolated)  
                              Thyristor TO-220 R Package (Non-isolated)  
                              Thyristor TO-263 N Package (Non-isolated)

Issue Date              August 12, 2010

It is hereby certified by Littelfuse, Inc., that there is neither RoHS (EU Directive 2002/95/EC)-restricted substance, nor such use, for materials to be used for unit parts, for packing/package materials, and for additives and the like in the manufacturing processes.

It is also certified by Littelfuse, Inc., that the products listed in this report do not contain Halogens and their compounds judged per widely accepted industrial guidelines.

In addition, it is hereby reported to you that the parts and sub-materials, the materials to be used for unit parts, the packing/package materials, and the additives and the like in the manufacturing processes, are all composed of the following components.

Issued by

\_\_\_\_\_  
< K. Yoshimoto, Senior Product Engineer, Littelfuse, L.P.>

(1) Parts, sub-materials and unit parts

This document covers Thyristor TO-220 Package products supplied by Littelfuse, Inc.  
Please see page 2 through 4 for the complete list of part number covered by this report.

(2) The analytical data on all measurable substances

Please see annex 1 through 9, attached to this document

Remarks :

**Pb (lead) contained in die bonding solder (item 8 on page 5) and passivation glass (item 7) to be categorized as exempt in RoHS Annex 5 and 7.**

**Please refer to Annex 10 of this report for the extract of the applicable exemptions of RoHS (EU Directive 2002/95/EC)**

**Littelfuse Part Number covered by this report (1/3)**  
**TO-220 L Package (Isolated)**

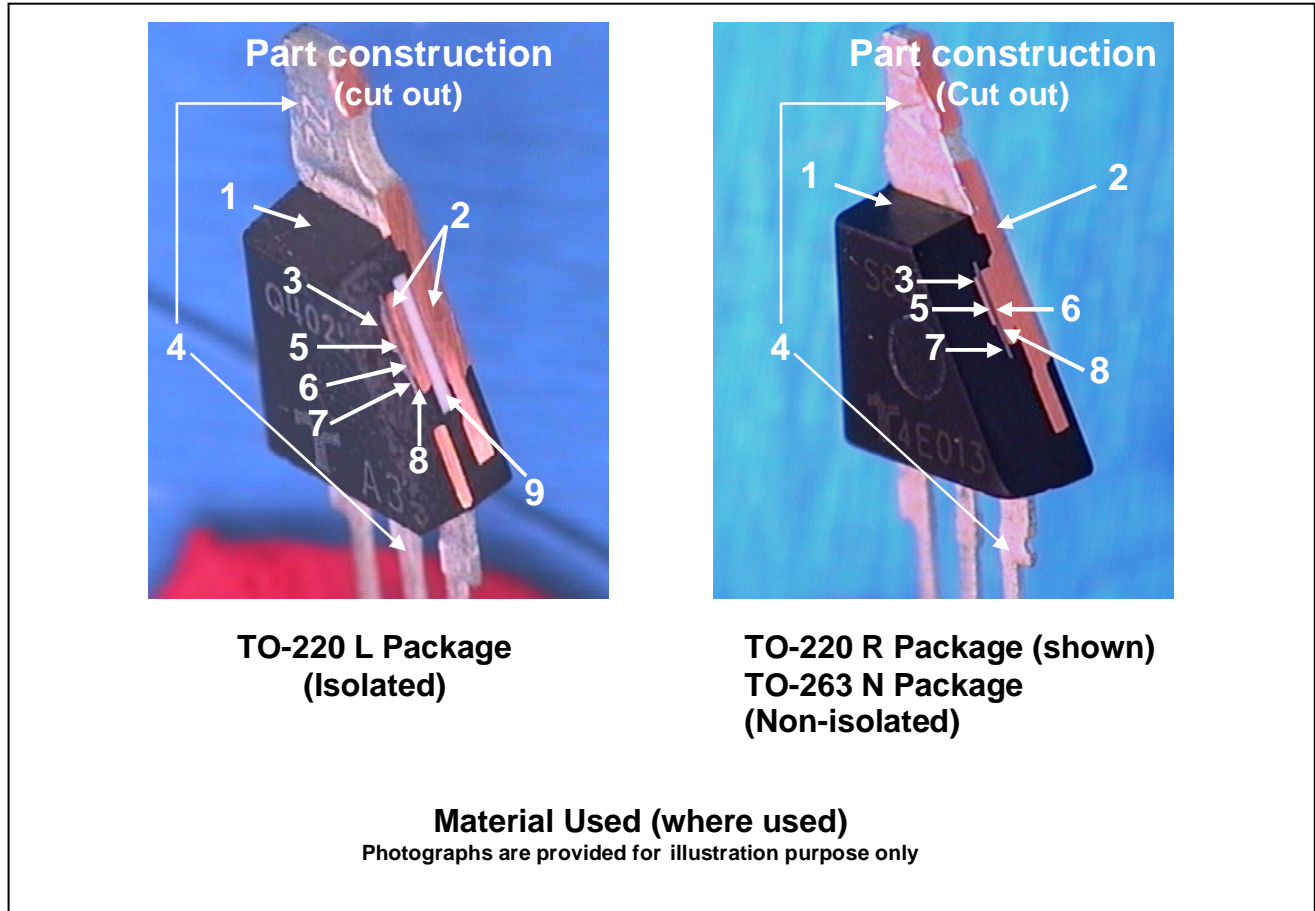
Standard (Catalog) Part Number					
HQ6025LH5	LTL08-800BH	Q2016LH6	Q6012LH5	QK016LH6	S4012L
	LTL08-800CH	Q2025L6	Q6015L5	QK025L6	S4015L
	LTL08-800SH	Q2030LH5	Q6015L6		S4020L
L2004L3	LTL08-800TH	Q4004L3	Q6016LH2		S4025L
L2004L5	LTL12-600BH	Q4004L4	Q6016LH3	S0508LS3	S5015L
L2004L6	LTL12-600CH	Q4004L5	Q6016LH4	S1015L	S5020L
L2004L8	LTL12-600SH	Q4006L4	Q6016LH6	S1020L	S6006L
L2006L5	LTL12-600TH	Q4006L5	Q6025L6	S2003LS2	S6006LS2
L2006L6	LTL12-800BH	Q4006LH4	Q6025L9	S2003LS3	S6006LS3
L2006L8	LTL12-800CH	Q4008L4	Q6025LX	S2006L	S6008L
L2008L6	LTL12-800SH	Q4008L5	Q6030LH5	S2006LS2	S6008LS2
L2008L8	LTL12-800TH	Q4008LH4	Q8004L4	S2006LS3	S6008LS3
L4004L3	LTL16-600BH	Q4010L4	Q8004L5	S2008L	S6010L
L4004L5	LTL16-600CH	Q4010L5	Q8006L5	S2008LS2	S6010LS2
L4004L6	LTL16-600SH	Q4010LH5	Q8006LH4	S2008LS3	S6010LS3
L4004L8	LTL16-800BH	Q4012LH2	Q8008L5	S2010L	S6012L
L4006L5	LTL16-800CH	Q4012LH5	Q8008LH4	S2010LS2	S6015L
L4006L6	LTL16-800SH	Q4015L5	Q8010L4	S2010LS3	S6020L
L4006L8	LTL25-600BH	Q4015L6	Q8010L5	S2012L	S6025L
L4008L6	LTL25-600CH	Q4016LH2	Q8010LH5	S2015L	S8006L
L4008L8	LTL25-800BH	Q4016LH3	Q8012LH5	S2020L	S8008L
L6004L3	LTL25-800CH	Q4016LH4	Q8015L5	S2025L	S8010L
L6004L5		Q4016LH6	Q8015L6	S4003LS2	S8015L
L6004L6		Q4025L6	Q8016LH2	S4006L	S8020L
L6004L8	Q2004L3	Q4025L6B	Q8016LH3	S4006LS2	S8025L
L6006L5	Q2004L4	Q4025LX	Q8016LH4	S4006LS3	SK006L
L6006L6	Q2004L5	Q4030LH5	Q8016LH6	S4008L	SK008L
L6006L8	Q2006L4	Q5015L6	Q8025L6	S4008LS2	SK010L
L6008L6	Q2006L5	Q5025LX	Q8025LX	S4008LS3	SK015L
L6008L8	Q2006LH4	Q6004L3	QK004L4	S4010L	SK020L
	Q2008L4	Q6004L4	QK006L5	S4010LS2	SK025L
	Q2008L5	Q6004L5	QK006LH4	S4010LS3	
LTL04-600CH	Q2008LH4	Q6006L4	QK008L5		
LTL04-600SH	Q2010L4	Q6006L5	QK008LH4	<b>SPECIAL DEVICE P/N</b>	
LTL04-600TH	Q2010L5	Q6006LH4	QK010L4	Any Special P/N that has base standard P/N listed in this table	
LTL04-800CH	Q2010LH5	Q6008L4	QK010L5		
LTL04-800SH	Q2012LH2	Q6008L5	QK010LH5	<b>OPTIONAL SUFFIX</b>	
LTL04-800TH	Q2012LH5	Q6008LH4	QK012LH5	Any Part Number listed in this table, including special part numbers, may be followed by suffix for packing options, such as "RP" or "TP", or lead form options such as "LB" or "51".	
LTL08-600BH	Q2015L5	Q6010L4	QK015L5		
LTL08-600CH	Q2015L6	Q6010L5	QK016LH2		
LTL08-600SH	Q2016LH3	Q6010LH5	QK016LH3		
LTL08-600TH	Q2016LH4	Q6012LH2	QK016LH4		

**Littelfuse Part Number covered by this report (2/3)**  
**TO-220 R Package (Non-isolated)**

Standard (Catalog) Part Number					
L6006R5	Q2008R4	Q6008RH3	QK012RH5	S8055R	
L6006R6	Q2008R5	Q6008RH4	QK015R5	SK008R	
L6008R6	Q2008RH4	Q6010R4	QK016RH2	SK010R	
	Q2010R4	Q6010R5	QK016RH3	SK012R	
	Q2010R5	Q6010RH5	QK016RH4	SK016R	
LTR04-600CH	Q2010RH5	Q6012R5	QK016RH6	SK025R	
LTR04-600SH	Q2012R5	Q6012RH2	QK025R5	SK040R	
LTR04-600TH	Q2012RH5	Q6012RH5	QK025R6	SK055R	
LTR04-800CH	Q2015R5	Q6015R5			
LTR04-800SH	Q2016RH3	Q6015R6			
LTR04-800TH	Q2016RH4	Q6016RH2	S2008R		
LTR08-600BH	Q2016RH6	Q6016RH3	S2010R		
LTR08-600CH	Q2025R5	Q6016RH4	S2012R		
LTR08-600SH	Q2025R6	Q6016RH6	S2016R		
LTR08-600TH	Q2035RH5	Q6025R5	S2025R		
LTR08-800BH	Q4004R4	Q6025R6	S2040R		
LTR08-800CH	Q4006R4	Q6025RX	S2055R		
LTR08-800SH	Q4006R5	Q6035RH5	S4006RS2		
LTR08-800TH	Q4006RH4	Q8006R5	S4008R		
LTR12-600BH	Q4008R4	Q8006RH4	S4010R		
LTR12-600CH	Q4008R5	Q8008R5	S4012R		
LTR12-600SH	Q4008RH4	Q8008RH4	S4016R		
LTR12-600TH	Q4010R4	Q8010R4	S4025R		
LTR12-800BH	Q4010R5	Q8010R5	S4040R		
LTR12-800CH	Q4010RH5	Q8010RH5	S4040RQ		
LTR12-800SH	Q4012R5	Q8012R5	S4055R		
LTR12-800TH	Q4012RH5	Q8012RH5	S5025R		
LTR16-600BH	Q4015R5	Q8015R5	S6006RS2		
LTR16-600CH	Q4015R6	Q8015R6	S6008R		
LTR16-600SH	Q4016RH2	Q8016RH2	S6008RS2		
LTR16-800BH	Q4016RH3	Q8016RH3	S6010R		
LTR16-800CH	Q4016RH6	Q8016RH4	S6012R		
LTR16-800SH	Q4025R5	Q8016RH6	S6016R		
LTR25-600BH	Q4025R6	Q8025R5	S6025R	<b>SPECIAL DEVICE P/N</b>	
LTR25-600CH	Q4035RH5	Q8025R6	S6040R	Any Special P/N that has base standard P/N listed in this table	
LTR25-800BH	Q6006R4	QK006R5	S6055R		
LTR25-800CH	Q6006R5	QK006RH4	S8008R	<b>OPTIONAL SUFFIX</b>	
	Q6006RH4	QK008R5	S8010R	Any Part Number listed in this table, including special part numbers, may be followed by suffix for packing options, such as "RP" or "TP", or lead form options such as "LB" or "51".	
	Q6008R4	QK008RH4	S8012R		
Q2006R4	Q6008R5	QK010R4	S8016R		
Q2006R5	Q6008R559	QK010R5	S8025R		
Q2006RH4	Q6008R567	QK010RH5	S8040R		

**Littelfuse Part Number covered by this report (3/3)  
TO-263 D<sup>2</sup> (N) Package (Non-isolated)**

Standard (Catalog) Part Number					
LTN04-600CH	Q2010NH5	Q6025NH6	S6016N		
LTN04-600SH	Q2012NH5	Q6035NH5	S6025N		
LTN04-600TH	Q2015N5	Q8006N5	S6040N		
LTN04-800CH	Q2016NH3	Q8006NH4	S6055N		
LTN04-800SH	Q2016NH4	Q8008N5	S8016N		
LTN04-800TH	Q2016NH6	Q8008NH4	S8025N		
LTN08-600BH	Q2025N5	Q8010N4	S8040N		
LTN08-600CH	Q2025NH6	Q8010N5	S8055N		
LTN08-600SH	Q2035NH5	Q8010NH5	SK016N		
LTN08-600TH	Q4006N4	Q8012NH5	SK025N		
LTN08-800BH	Q4006N5	Q8015N5	SK040N		
LTN08-800CH	Q4006NH4	Q8016NH3	SK055N		
LTN08-800SH	Q4008N4	Q8016NH4			
LTN08-800TH	Q4008N5	Q8016NH6			
LTN12-600BH	Q4008NH4	Q8025N5			
LTN12-600CH	Q4010N4	Q8025NH6			
LTN12-600SH	Q4010N5	QK006N5			
LTN12-600TH	Q4010NH5	QK006NH4			
LTN12-800BH	Q4012NH5	QK008N5			
LTN12-800CH	Q4015N5	QK008NH4			
LTN12-800SH	Q4016NH3	QK010N4			
LTN12-800TH	Q4016NH4	QK010N5			
LTN16-600BH	Q4016NH6	QK010NH5			
LTN16-600CH	Q4025N5	QK012NH5			
LTN16-600SH	Q4025NH6	QK015N5			
LTN16-800BH	Q4035NH5	QK016NH3			
LTN16-800CH	Q6006N4	QK016NH4			
LTN16-800SH	Q6006N5	QK016NH6			
LTN25-600BH	Q6006NH4	QK025N5			
LTN25-600CH	Q6008N4	QK025NH6			
LTN25-800BH	Q6008N5				
LTN25-800CH	Q6008NH4				
	Q6010N4	S2016N			
	Q6010N5	S2025N			<b>SPECIAL DEVICE P/N</b>
Q2006N4	Q6010NH5	S2040N			Any Special P/N that has base standard P/N listed in this table
Q2006N5	Q6012NH5	S2055N			
Q2006NH4	Q6015N5	S4016N			<b>OPTIONAL SUFFIX</b>
Q2008N4	Q6016NH2	S4025N			Any Part Number listed in this table, including special part numbers, may be followed by suffix for packing options, such as "RP" or "TP", or lead form options such as "LB" or "51".
Q2008N5	Q6016NH3	S4040N			
Q2008NH4	Q6016NH4	S4040NQ			
Q2010N4	Q6016NH6	S4040NQ2			
Q2010N5	Q6025N5	S4055N			


**Table 1: Homogeneous Material Used**

#	Description	Name of Material	Type	Analysis data
1	Molding compound	epoxy resin	plastic	annex 1
2	Lead frame	copper alloy	metal	annex 2
3	Clip	copper alloy	metal	annex 3 TO-220/263 uses the same copper material as DO-214. ICP report is from DO-214 Material.
4	Matte-Tin plating	Tin	metal	annex 4
5	Silicon die	silicon	metal	annex 5, tested as Nickel-plated wafer.
6	Nickel electrode	nickel	metal	
7	Passivation glass	glass	glass	annex 6. Pb in this glass is exempted by RoHS Annex 5.
8	Die bonding solder	solder	metal	annex 7. Pb in this solder is exempted by RoHS Annex 7.
9	Substrate	alumina	ceramic	annex 8 (TO-220L package only)
10	Marking Ink	polymer	plastic	annex 9 (TO-220L package only)

**Table 2: RoHS-regulated substance in raw materials (1/2)  
TO-220 L Package (Isolated)**

Components	Analysis Result						
	Cd Cadmium	Cr Chromium	Hg Mercury	Pb Lead	PBB	PBDE	Total Halogen
<b>As Component Total</b> (Values of Q6025L6* <sup>1</sup> , as representative of Thyristor, TO-220L Package)	< 2ppm	< 2ppm	< 2ppm	<13 ppm* <sup>2</sup> (1.3%* <sup>3</sup> )	< 5 ppm	< 5 ppm	< 100 ppm
<b>Epoxy Resin compound</b> (mixture of phenolix resin, epoxy resin, filler and metal hydroxide as fire retardant) See Annex 1 for the detail.	< 2ppm	< 1ppm	< 2ppm	< 2ppm	< 5ppm	< 5ppm	100ppm
<b>Lead frame / Preform</b> (Copper Alloy, C14420 / CDA110) See Annex 2 & 3 for the detail.	< 2ppm	< 2ppm	< 2ppm	23ppm * <sup>6</sup>	---	---	---
<b>Outside lead finish</b> (Matte-Tin plated, Sn 100%) See Annex 4 for the detail.	< 2ppm	< 2ppm	< 2ppm	173ppm* <sup>6</sup>	< 5ppm	< 5ppm	<50ppm
<b>Silicon Die</b> (Silicon + Ni electrode) See Annex 5 for the detail.	< 2ppm	< 2ppm	< 2ppm	< 2ppm	< 5ppm	< 5ppm	<50ppm
<b>Passivation Glass</b> See Annex 6 for the detail.	< 2ppm	< 2ppm	< 2ppm	40% * <sup>4</sup>	< 5ppm	< 5ppm	<50pm
<b>Die Bonding Solder</b> (Pb/Sn=90/10) See Annex 7 for the detail.	< 2ppm	< 2ppm	< 2ppm	90% * <sup>5</sup>	< 5ppm	< 5ppm	<50ppm
<b>Ceramic Substrate for isolation</b> (Alumina ceramic) See Annex 8 for the detail.	< 2ppm	< 1ppm	< 2ppm	< 2ppm	---	---	---
<b>Marking Ink</b> (Plastic) See Annex 9 for the detail.	< 2ppm	< 2ppm	< 2ppm	211ppm * <sup>6</sup>	< 5ppm	< 5ppm	112ppm

\*1 Other products may contain equal or less amount of Pb as Q6025L6 value shown here, but not more than the value shown here.

\*2 Less than 10ppm Pb content overall, excluding Pb from the die bonding solder and the passivation glass on the silicon die.

\*3 1.3wt% or 30mg of Pb (lead) content overall, including the RoHS-exempted use of Pb

\*4 Pb (lead) contained in passivation glass is exempted from restriction by RoHS Annex 5.

\*5 Pb (lead) contained in die bonding solder is exempted from restriction by RoHS Annex 7, first item.

\*6 Pb (lead) contained in lead frame, plating and marking ink are process contamination or naturally-occurring impurity in raw materials. Littelfuse does not add Pb intentionally.

**Please refer to Annex 10 of this report for the applicable exemptions of RoHS (EU Directive 2002/95/EC)**

**Table 2: RoHS-regulated substance in raw materials (2/2)**  
**TO-220 R Package and TO-263 N Package (Non-isolated)**

Components	Analysis Result						
	Cd Cadmium	Cr Chromium	Hg Mercury	Pb Lead	PBB	PBDE	Total Halogen
<b>As Component Total</b> (Values of S8055R* <sup>1</sup> , as representative of Thyristor, TO-220R and TO-263 N Package)	< 2ppm	< 2ppm	< 2ppm	<13 ppm* <sup>2</sup> (0.95%* <sup>3</sup> )	< 5 ppm	< 5 ppm	< 100 ppm
<b>Epoxy Resin compound</b> (mixture of phenolix resin, epoxy resin, filler and metal hydroxide as fire retardant) See Annex 1 for the detail.	< 2ppm	< 1ppm	< 2ppm	< 2ppm	< 5ppm	< 5ppm	100ppm
<b>Lead frame / Preform</b> (Copper Alloy, C14420 / CDA110)  See Annex 2 & 3 for the detail.	< 2ppm	< 2ppm	< 2ppm	23ppm * <sup>6</sup>	---	---	---
<b>Outside lead finish</b> (Matte-Tin plated, Sn 100%)  See Annex 4 for the detail.	< 2ppm	< 2ppm	< 2ppm	173ppm* <sup>6</sup>	< 5ppm	< 5ppm	<50ppm
<b>Silicon Die</b> (Silicon + Ni electrode)  See Annex 5 for the detail.	< 2ppm	< 2ppm	< 2ppm	<2ppm	< 5ppm	< 5ppm	<50ppm
<b>Passivation Glass</b>  See Annex 6 for the detail.	< 2ppm	< 2ppm	< 2ppm	40% * <sup>4</sup>	< 5ppm	< 5ppm	<50ppm
<b>Die Bonding Solder</b> (Pb/Sn=90/10)  See Annex 7 for the detail.	< 2ppm	< 2ppm	< 2ppm	90% * <sup>5</sup>	< 5ppm	< 5ppm	<50ppm

\*1 Other products may contain equal or less amount of Pb as S8055R value shown here, but not more than the value shown here.

\*2 Less than 10ppm Pb content overall, excluding Pb from the die bonding solder and the passivation glass on the silicon die.

\*3 0.95wt% or 21mg of Pb (lead) content overall, including the RoHS-exempted use of Pb

\*4 Pb (lead) contained in passivation glass is exempted from restriction by RoHS Annex 5.

\*5 Pb (lead) contained in die bonding solder is exempted from restriction by RoHS Annex 7, first item.

\*6 Pb (lead) contained in lead frame, plating and plating is process contamination or naturally-occurring impurity in raw materials. Littelfuse does not add Pb intentionally.

Please refer to Annex 10 of this report for the applicable exemptions of RoHS (EU Directive 2002/95/EC)

**Annex 1: Analysis Result of Molding Compound (Page 1 of 7)****TEST REPORT**

NUMBER: WUXH00002758

APPLICANT: CONCORD SEMICONDUCTOR(WUXI) CO., LTD.  
DATE: AUG 06, 2010  
EAST 1#, ZHENFA 6 ROAD, SHUO FANG  
INDUSTRIAL PARK WUXI NATIONAL HIGH-  
TECH DEVELOPMENT ZONE,  
WUXI, JIANGSU, CHINA  
ATTN: ZHANG XIAOPENG

## SAMPLE DESCRIPTION:

ONE(1)PIECE OF SUBMITTED SAMPLE SAID TO BE :**BLACK COMPOUND**.  
ITEM NAME : MOLDING COMPOUND.  
VENDOR : COOKSON ELECTONICS SEMICONDUCTOR PRODUCTS.  
COMPONENT OR PART NO. : CK2000C.  
TEST ITEM : Pb, Cd, Hg, CrVI, PBB PBDE, F, Cl, Br, I.

## TESTS CONDUCTED:

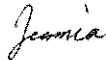
AS REQUESTED BY THE APPLICANT, FOR DETAILS REFER TO ATTACHED PAGE(S)  
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## SUMMARY:

<u>TESTED SAMPLE</u>	<u>STANDARD</u>	<u>RESULT</u>
SUBMITTED SAMPLE	WITH REFERENCE TO TEST METHOD OF IEC 62321 EDITION 1.0: 2008 AND MAXIMUM CONCENTRATION LIMITS QUOTED FROM RoHS DIRECTIVES 2002/95/EC AND AMENDMENT 2005/618/EC	PASS

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TO BE CONTINUED

PREPARED AND CHECKED BY:  
FOR INTERTEK TESTING SERVICES WUXI LTD.



JESSICA LU  
GENERAL MANAGER

PAGE 1 OF 7

**Intertek Testing Services Wuxi Ltd.**  
No.8 Fubei Road, Xishan Economic Development Zone,  
Wuxi 214101, Jiangsu, China  
Tel: +86 510 8821 4567 Fax: +86 510 8820 0428 E-mail: consumergoods.wuxi@intertek.com



## Annex 1: Analysis Result of Molding Compound (Page 2 of 7)


**TEST REPORT**

NUMBER: WUXH00002758

## TESTS CONDUCTED

## (A) TEST RESULT SUMMARY:

TESTING ITEM	RESULT
CADMIUM (Cd) CONTENT (mg/kg)	ND
LEAD (Pb) CONTENT (mg/kg)	ND
MERCURY (Hg) CONTENT (mg/kg)	ND
CHROMIUM (VI) (Cr <sup>6+</sup> ) CONTENT (mg/kg) (FOR NON-METAL)	ND
POLYBROMINATED BIPHENYLS (PBBs) (mg/kg)	
MONOBROMO BIPHENYLS (MonoBB)	ND
DIBROMO BIPHENYLS (DiBB)	ND
TRIBROMO BIPHENYLS (TriBB)	ND
TETRABROMO BIPHENYLS (TetraBB)	ND
PENTABROMO BIPHENYLS (PentaBB)	ND
HEXABROMO BIPHENYLS (HexaBB)	ND
HEPTABROMO BIPHENYLS (HeptaBB)	ND
OCTABROMO BIPHENYLS (OctaBB)	ND
NONABROMO BIPHENYLS (NonaBB)	ND
DECABROMO BIPHENYL (DecaBB)	ND
POLYBROMINATED DIPHENYL ETHERS (PBDEs) (mg/kg)	
MONOBROMO DIPHENYL ETHERS (MonoBDE)	ND
DIBROMO DIPHENYL ETHERS (DiBDE)	ND
TRIBROMO DIPHENYL ETHERS (TriBDE)	ND
TETRABROMO DIPHENYL ETHERS (TetraBDE)	ND
PENTABROMO DIPHENYL ETHERS (PentaBDE)	ND
HEXABROMO DIPHENYL ETHERS (HexaBDE)	ND
HEPTABROMO DIPHENYL ETHERS (HeptaBDE)	ND
OCTABROMO DIPHENYL ETHERS (OctaBDE)	ND
NONABROMO DIPHENYL ETHERS (NonaBDE)	ND
DECABROMO DIPHENYL ETHER (DecaBDE)	ND

## REMARK:

mg/kg = MILLIGRAM PER KILOGRAM BASED ON DRY WEIGHT= ppm

ND = NOT DETECTED

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TO BE CONTINUED

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**Intertek Testing Services Wuxi Ltd.**

 No.8 Fubei Road, Xishan Economic Development Zone,  
Wuxi 214101, Jiangsu, China

Tel: +86 510 8821 4567 Fax: +86 510 8820 0428 E-mail: consumergoods.wuxi@intertek.com

## Annex 1: Analysis Result of Molding Compound (Page 3 of 7)


**TEST REPORT**

NUMBER: WUXH00002758

## TESTS CONDUCTED

## (B) RoHS REQUIREMENT:

RESTRICTED SUBSTANCES	LIMITS
CADMIUM (Cd)	0.01% (100 mg/kg)
LEAD (Pb)	0.1% (1000 mg/kg)
MERCURY (Hg)	0.1% (1000 mg/kg)
CHROMIUM (VI) (Cr <sup>6+</sup> )	0.1% (1000 mg/kg)
POLYBROMINATED BIPHENYLS (PBBs)	0.1% (1000 mg/kg)
POLYBROMINATED DIPHENYL ETHERS (PBDEs)	0.1% (1000 mg/kg)

THE ABOVE LIMITS WERE QUOTED FROM 2002/95/EC AND AMENDMENT 2005/618/EC FOR HOMOGENEOUS MATERIAL.

## (c) TEST METHOD:

TESTING ITEM	TESTING METHOD	REPORTING LIMIT
CADMIUM (Cd) CONTENT	WITH REFERENCE TO IEC 62321 EDITION 1.0: 2008, BY ACID DIGESTION AND DETERMINED BY ICP-OES	2 mg/kg
LEAD (Pb) CONTENT	WITH REFERENCE TO IEC 62321 EDITION 1.0: 2008, BY ACID DIGESTION AND DETERMINED BY ICP-OES	2 mg/kg
MERCURY (Hg) CONTENT	WITH REFERENCE TO IEC 62321 EDITION 1.0: 2008, BY ACID DIGESTION AND DETERMINED BY ICP-OES	2 mg/kg
CHROMIUM (VI) (Cr <sup>6+</sup> ) CONTENT (FOR NON-METAL)	WITH REFERENCE TO IEC 62321 EDITION 1.0: 2008, BY ALKALINE DIGESTION AND DETERMINED BY UV-VIS SPECTROPHOTOMETER	1 mg/kg
POLYBROMINATED BIPHENYLS (PBBs) & POLYBROMINATED DIPHENYL ETHERS (PBDEs)	WITH REFERENCE TO IEC IEC 62321 EDITION 1.0: 2008, BY SOLVENT EXTRACTION AND DETERMINED BY GC/MS AND FURTHER HPLC CONFIRMATION WHEN NECESSARY.	5 mg/kg

DATE SAMPLE RECEIVED:AUG 02, 2010

TESTING PERIOD:AUG 02, 2010 TO AUG 05, 2010

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TO BE CONTINUED

PAGE 3 OF 7

**Intertek Testing Services Wuxi Ltd.**

 No 8 Fubei Road, Xishan Economic Development Zone,  
 Wuxi 214101, Jiangsu, China

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## Annex 1: Analysis Result of Molding Compound (Page 4 of 7)

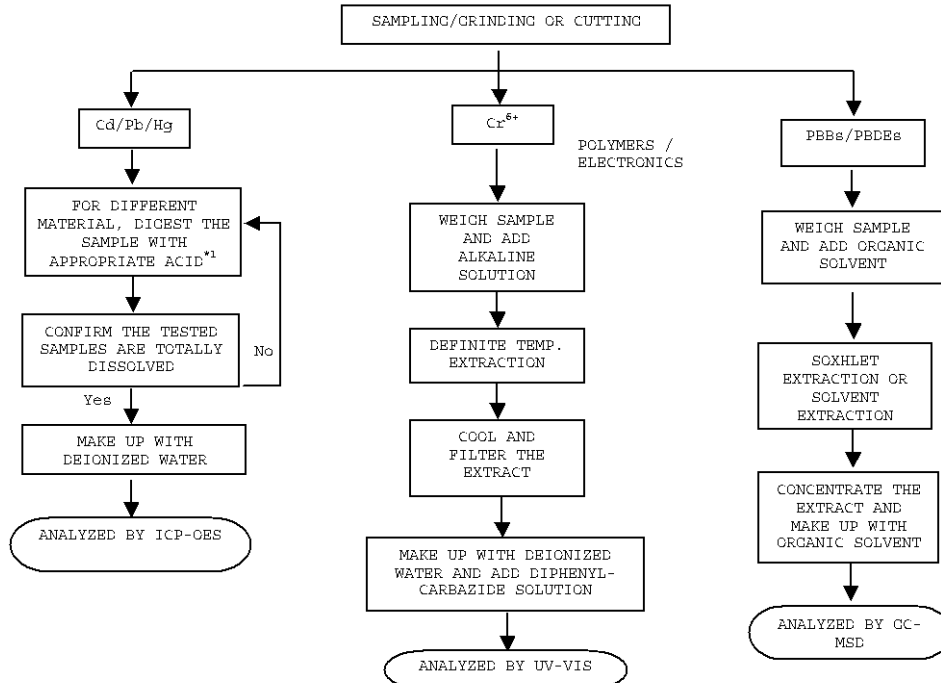


### TEST REPORT

NUMBER: WUXH00002758

#### TESTS CONDUCTED

(D) MEASUREMENT FLOWCHART:  
 TEST FOR Cd/Pb/Hg/Cr (VI)/PBBs/PBDEs CONTENTS  
 REFERENCE STANDARD: IEC 62321 EDITION 1.0: 2008



CHEMIST: INORGANIC (ANN LUO/FRED WANG/ALLY WAN)  
 ORGANIC (JENNY XU/CHERRY SUN)

#### REMARKS:

\*1: LIST OF APPROPRIATE ACID:

MATERIAL	ACID ADDED FOR DIGESTION
POLYMERS	HNO <sub>3</sub> , HCl, HF, H <sub>2</sub> O <sub>2</sub> , H <sub>3</sub> BO <sub>3</sub>
METALS	HNO <sub>3</sub> , HCl, HF
ELECTRONICS	HNO <sub>3</sub> , HCl, H <sub>2</sub> O <sub>2</sub> , HBF <sub>4</sub>

\*2: IF THE RESULT OF SPOT TEST IS POSITIVE, CHROMIUM VI WOULD BE DETERMINED AS DETECTED.

\*\*\*\*\*

TO BE CONTINUED

PAGE 4 OF 7

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## Annex 1: Analysis Result of Molding Compound (Page 5 of 7)


**TEST REPORT**

NUMBER: WUXH00002758

## TESTS CONDUCTED

## (I) TEST RESULT SUMMARY :

## HALOGEN CONTENT :

TESTING ITEM	RESULT (ppm)
FLUORINE (F) CONTENT	ND
CHLORINE (Cl) CONTENT	100
BROMINE (Br) CONTENT	ND
IODINE (I) CONTENT	ND

REMARKS : ppm = PARTS PER MILLION = mg/kg

ND = NOT DETECTED

DATE SAMPLE RECEIVE: AUG 02, 2010

TEST PERIOD: AUG 02, 2010 TO AUG 05, 2010

## (II) TEST METHOD :

TESTING ITEM	TESTING METHOD	REPORTING LIMIT
HALOGEN (F, Cl, Br, I) CONTENT	WITH REFERENCE TO IEC 61189-2:2006 BY COMBUSTION FLASK AND DETERMINED BY ION CHROMATOGRAPHY	50 ppm

REMARKS : REPORTING LIMIT = QUANTITATION LIMIT OF ANALYTE IN SAMPLE

\*\*\*\*\*

TO BE CONTINUED

PAGE 5 OF 7

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### Annex 1: Analysis Result of Molding Compound (Page 6 of 7)



**TEST REPORT**

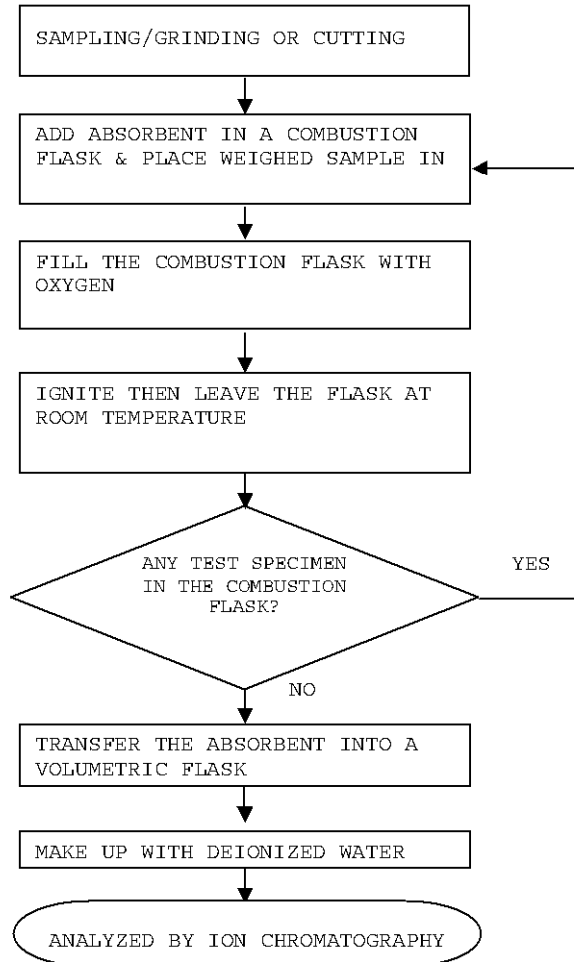
NUMBER: WUXH00002758

TESTS CONDUCTED

(III) MEASUREMENT FLOWCHART:

TEST FOR HALOGEN CONTENT

REFERENCE METHOD: IEC 61189-2 TEST 2C12



CHEMIST: FRED WANG/ ALLY WAN

\*\*\*\*\*  
TO BE CONTINUED

# Annex 1: Analysis Result of Molding Compound (Page 7 of 7)

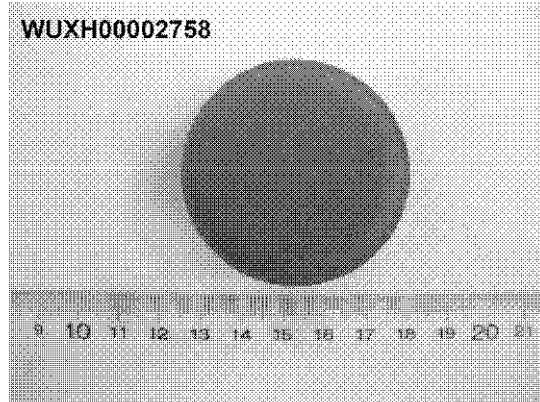


TEST REPORT

NUMBER: WUXH00002758

TESTS CONDUCTED

PHOTO



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END OF REPORT

PAGE 7 OF 7

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**Annex 2: Analysis Result of Lead frame (Page 1 of 5)****Intertek**TEST REPORT

NUMBER: WUXH00002730

APPLICANT: CONCORD SEMICONDUCTOR(WUXI) CO., LTD.  
DATE: AUG 06, 2010  
EAST 1#, ZHENFA 6 ROAD, SHUO FANG  
INDUSTRIAL PARK WUXI NATIONAL HIGH-  
TECH DEVELOPMENT ZONE,  
WUXI, JIANGSU, CHINA  
ATTN: ZHANG XIAOPENG

## SAMPLE DESCRIPTION:

ONE (1) PIECE OF SUBMITTED SAMPLE SAID TO BE : **COPPER METAL**.  
ITEM NAME : LEAD FRAME/LEAD FRAME MATRIX/TO-220 LEAD  
FRAME/HEATSINK.  
VENDOR : JINAN JIHLONG TECHNOLOGY CO., LTD.  
COMPONENT OR PART NO. : COPPER.  
TEST ITEM : Pb, Cd, Hg, CrVI.

\*\*\*\*\*  
TESTS CONDUCTED:

AS REQUESTED BY THE APPLICANT, FOR DETAILS REFER TO ATTACHED PAGE(S)

\*\*\*\*\*

## SUMMARY:

<u>TESTED SAMPLE</u>	<u>STANDARD</u>	<u>RESULT</u>
SUBMITTED SAMPLE	WITH REFERENCE TO TEST METHOD OF IEC 62321 EDITION 1.0: 2008 AND MAXIMUM CONCENTRATION LIMITS QUOTED FROM ROHS DIRECTIVES 2002/95/EC AND AMENDMENT 2005/618/EC	PASS

\*\*\*\*\*  
TO BE CONTINUED

PREPARED AND CHECKED BY:  
FOR INTERTEK TESTING SERVICES WUXI LTD.



JESSICA LU  
GENERAL MANAGER

PAGE 1 OF 5

**Intertek Testing Services Wuxi Ltd.**  
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**Annex 2: Analysis Result of Lead frame (Page 2 of 5)****Intertek**TEST REPORT

NUMBER: WUXH00002730

APPLICANT: CONCORD SEMICONDUCTOR(WUXI) CO., LTD.  
EAST 1#, ZHENFA 6 ROAD, SHUO FANG  
INDUSTRIAL PARK WUXI NATIONAL HIGH-  
TECH DEVELOPMENT ZONE,  
WUXI, JIANGSU, CHINA  
ATTN: ZHANG XIAOPENG

DATE: AUG 06, 2010

## SAMPLE DESCRIPTION:

ONE (1) PIECE OF SUBMITTED SAMPLE SAID TO BE : **COPPER METAL**.

ITEM NAME : LEAD FRAME/LEAD FRAME MATRIX/TO-220 LEAD  
FRAME/HEATSINK.

VENDOR : JINAN JIHLONG TECHNOLOGY CO., LTD.

COMPONENT OR PART NO. : COPPER.

TEST ITEM : Pb, Cd, Hg, CrVI.

\*\*\*\*\*  
TESTS CONDUCTED:

AS REQUESTED BY THE APPLICANT, FOR DETAILS REFER TO ATTACHED PAGE(S)

\*\*\*\*\*

## SUMMARY:

<u>TESTED SAMPLE</u>	<u>STANDARD</u>	<u>RESULT</u>
SUBMITTED SAMPLE	WITH REFERENCE TO TEST METHOD OF IEC 62321 EDITION 1.0: 2008 AND MAXIMUM CONCENTRATION LIMITS QUOTED FROM ROHS DIRECTIVES 2002/95/EC AND AMENDMENT 2005/618/EC	PASS

\*\*\*\*\*

TO BE CONTINUED

PREPARED AND CHECKED BY:  
FOR INTERTEK TESTING SERVICES WUXI LTD.



JESSICA LU  
GENERAL MANAGER

PAGE 1 OF 5

**Intertek Testing Services Wuxi Ltd.**  
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## Annex 2: Analysis Result of Lead frame (Page 3 of 5)


**TEST REPORT**

NUMBER: WUXH00002730

TESTS CONDUCTED

(c) TEST METHOD:

<u>TESTING ITEM</u>	<u>TESTING METHOD</u>	<u>REPORTING LIMIT</u>
CADMIUM (Cd) CONTENT	WITH REFERENCE TO IEC 62321 EDITION 1.0: 2008, BY ACID DIGESTION AND DETERMINED BY ICP-OES	2 mg/kg
LEAD (Pb) CONTENT	WITH REFERENCE TO IEC 62321 EDITION 1.0: 2008, BY ACID DIGESTION AND DETERMINED BY ICP-OES	2 mg/kg
MERCURY (Hg) CONTENT	WITH REFERENCE TO IEC 62321 EDITION 1.0: 2008, BY ACID DIGESTION AND DETERMINED BY ICP-OES	2 mg/kg
CHROMIUM (VI) (Cr <sup>6+</sup> ) CONTENT (FOR METAL)	WITH REFERENCE TO IEC 62321 EDITION 1.0: 2008, BY BOILING WATER EXTRACTION AND DETERMINED BY UV-VIS SPECTROPHOTOMETER	0.02mg/kg WITH 50cm <sup>2</sup> (IN TESTING SOLUTION)

DATE SAMPLE RECEIVED:AUG 02, 2010

TESTING PERIOD:AUG 02, 2010 TO AUG 05, 2010

\*\*\*\*\*

TO BE CONTINUED

PAGE 3 OF 5

**Intertek Testing Services Wuxi Ltd.**

 No.8 Fubei Road, Xishan Economic Development Zone,  
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## Annex 2: Analysis Result of Lead frame (Page 4 of 5)

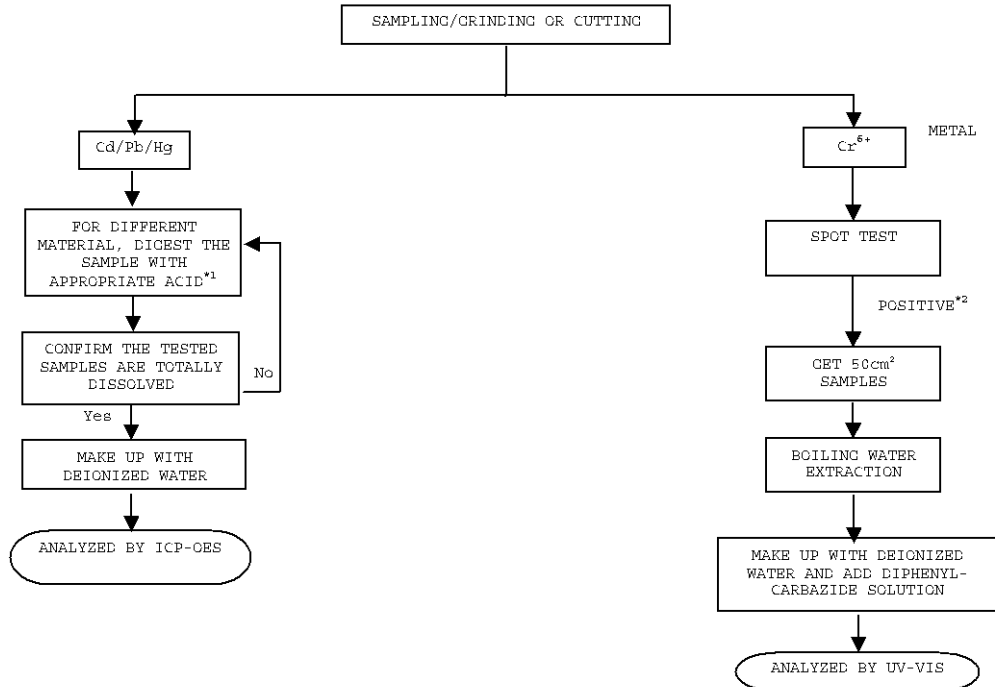


### TEST REPORT

NUMBER: WUXH00002730

#### TESTS CONDUCTED

(D) MEASUREMENT FLOWCHART:  
 TEST FOR Cd/Pb/Hg/Cr (VI) CONTENTS  
 REFERENCE STANDARD: IEC 62321 EDITION 1.0: 2008



CHEMIST: INORGANIC (ANN LUO/FRED WANG/ALLY WAN)

REMARKS:

\*1: LIST OF APPROPRIATE ACID:

MATERIAL	ACID ADDED FOR DIGESTION
POLYMERS	HNO <sub>3</sub> , HCl, HF, H <sub>2</sub> O <sub>2</sub> , H <sub>3</sub> BO <sub>3</sub>
METALS	HNO <sub>3</sub> , HCl, HF
ELECTRONICS	HNO <sub>3</sub> , HCl, H <sub>2</sub> O <sub>2</sub> , HBF <sub>4</sub>

\*2: IF THE RESULT OF SPOT TEST IS POSITIVE, CHROMIUM VI WOULD BE DETERMINED AS DETECTED.

\*\*\*\*\*

TO BE CONTINUED

PHOTO

PAGE 4 OF 5

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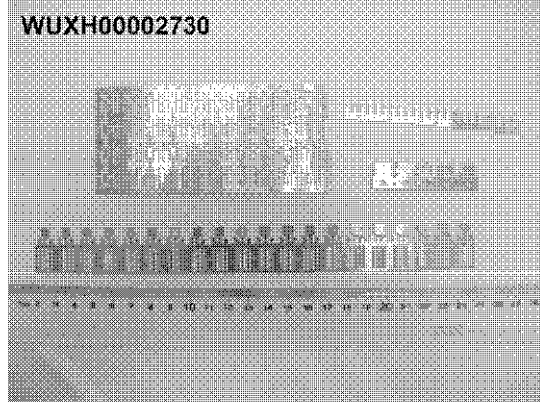
## Annex 2: Analysis Result of Lead frame (Page 5 of 5)



TEST REPORT

NUMBER: WUXH00002730

TESTS CONDUCTED



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END OF REPORT

PAGE 5 OF 5

**Intertek Testing Services Wuxi Ltd.**  
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**Annex 3: Analysis Result of Clip (Page 1 of 5)****Intertek**TEST REPORT

NUMBER: WUXH00002736

APPLICANT: CONCORD SEMICONDUCTOR (WUXI) CO., LTD.  
DATE: AUG 06, 2010  
EAST 1#, ZHENFA 6 ROAD, SHUO FANG  
INDUSTRIAL PARK WUXI NATIONAL HIGH-  
TECH DEVELOPMENT ZONE,  
WUXI, JIANGSU, CHINA  
ATTN: ZHANG XIAOPENG

## SAMPLE DESCRIPTION:

ONE (1) PIECE OF SUBMITTED SAMPLE SAID TO BE : **COPPER METAL**.  
ITEM NAME : CLIP.  
VENDOR : G-SHANK PRECISION MACHINERY  
(SUZHOU) CO., LTD.  
COMPONENT OR PART NO. : COPPER.  
TEST ITEM : Pb, Cd, Hg, CrVI.

\*\*\*\*\*  
TESTS CONDUCTED:

AS REQUESTED BY THE APPLICANT, FOR DETAILS REFER TO ATTACHED PAGE(S)

\*\*\*\*\*

## SUMMARY:

<u>TESTED SAMPLE</u>	<u>STANDARD</u>	<u>RESULT</u>
SUBMITTED SAMPLE	WITH REFERENCE TO TEST METHOD OF IEC 62321 EDITION 1.0: 2008 AND MAXIMUM CONCENTRATION LIMITS QUOTED FROM ROHS DIRECTIVES 2002/95/EC AND AMENDMENT 2005/618/EC	PASS

\*\*\*\*\*

TO BE CONTINUED

PREPARED AND CHECKED BY:  
FOR INTERTEK TESTING SERVICES WUXI LTD.



JESSICA LU  
GENERAL MANAGER

PAGE 1 OF 5

**Intertek Testing Services Wuxi Ltd.**  
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### Annex 3: Analysis Result of Clip (Page 2 of 5)



**TEST REPORT**

NUMBER: WUXH00002736

TESTS CONDUCTED

(A) TEST RESULT SUMMARY:

TESTING ITEM	RESULT
CADMIUM (Cd) CONTENT (mg/kg)	ND
LEAD (Pb) CONTENT (mg/kg)	12
MERCURY (Hg) CONTENT (mg/kg)	ND
CHROMIUM (VI) (Cr <sup>6+</sup> ) RESULT (BY BOILING WATER EXTRACTION ON METAL) (mg/kg WITH 50cm <sup>2</sup> )	ND

REMARK:

mg/kg = MILLIGRAM PER KILOGRAM BASED ON DRY WEIGHT= ppm  
 mg/kg WITH 50cm<sup>2</sup> = MILLIGRAM PER KILOGRAM WITH 50 SQUARE CENTIMETER  
 ND = NOT DETECTED

(B) RoHS REQUIREMENT:

RESTRICTED SUBSTANCES	LIMITS
CADMIUM (Cd)	0.01% (100 mg/kg)
LEAD (Pb)	0.1% (1000 mg/kg)
MERCURY (Hg)	0.1% (1000 mg/kg)
CHROMIUM (VI) (Cr <sup>6+</sup> )	0.1% (1000 mg/kg)

THE ABOVE LIMITS WERE QUOTED FROM 2002/95/EC AND AMENDMENT 2005/618/EC FOR HOMOGENEOUS MATERIAL.

\*\*\*\*\*

TO BE CONTINUED

### Annex 3: Analysis Result of Clip (Page 3 of 5)

**Intertek**

**TEST REPORT**

NUMBER: WUXH00002736

TESTS CONDUCTED

(c) TEST METHOD:

<u>TESTING ITEM</u>	<u>TESTING METHOD</u>	<u>REPORTING LIMIT</u>
CADMIUM (Cd) CONTENT	WITH REFERENCE TO IEC 62321 EDITION 1.0: 2008, BY ACID DIGESTION AND DETERMINED BY ICP-OES	2 mg/kg
LEAD (Pb) CONTENT	WITH REFERENCE TO IEC 62321 EDITION 1.0: 2008, BY ACID DIGESTION AND DETERMINED BY ICP-OES	2 mg/kg
MERCURY (Hg) CONTENT	WITH REFERENCE TO IEC 62321 EDITION 1.0: 2008, BY ACID DIGESTION AND DETERMINED BY ICP-OES	2 mg/kg
CHROMIUM (VI) (Cr <sup>6+</sup> ) CONTENT (FOR METAL)	WITH REFERENCE TO IEC 62321 EDITION 1.0: 2008, BY BOILING WATER EXTRACTION AND DETERMINED BY UV-VIS SPECTROPHOTOMETER	0.02mg/kg WITH 50cm <sup>2</sup> (IN TESTING SOLUTION)

DATE SAMPLE RECEIVED:AUG 02, 2010

TESTING PERIOD:AUG 02, 2010 TO AUG 05, 2010

\*\*\*\*\*

TO BE CONTINUED

PAGE 3 OF 5

**Intertek Testing Services Wuxi Ltd.**

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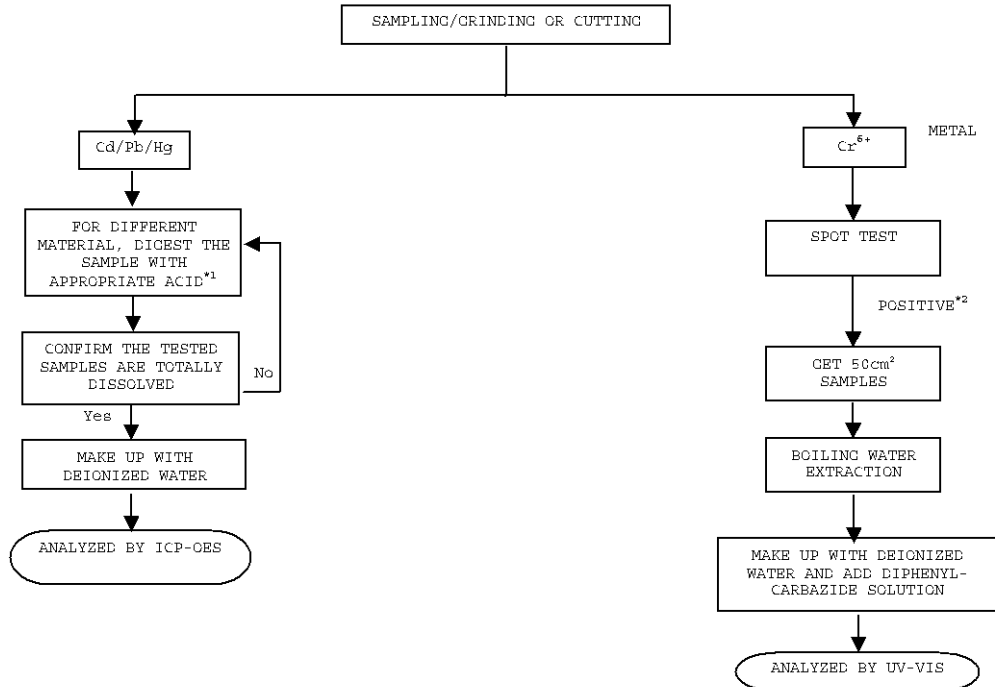
### Annex 3: Analysis Result of Clip (Page 4 of 5)


**TEST REPORT**

NUMBER: WUXH00002736

**TESTS CONDUCTED**

(D) MEASUREMENT FLOWCHART:  
 TEST FOR Cd/Pb/Hg/Cr (VI) CONTENTS  
 REFERENCE STANDARD: IEC 62321 EDITION 1.0: 2008



CHEMIST: INORGANIC (ANN LUO/FRED WANG/ALLY WAN)

REMARKS:

\*1: LIST OF APPROPRIATE ACID:

MATERIAL	ACID ADDED FOR DIGESTION
POLYMERS	HNO <sub>3</sub> , HCl, HF, H <sub>2</sub> O <sub>2</sub> , H <sub>3</sub> BO <sub>3</sub>
METALS	HNO <sub>3</sub> , HCl, HF
ELECTRONICS	HNO <sub>3</sub> , HCl, H <sub>2</sub> O <sub>2</sub> , HBF <sub>4</sub>

\*2: IF THE RESULT OF SPOT TEST IS POSITIVE, CHROMIUM VI WOULD BE DETERMINED AS DETECTED.

\*\*\*\*\*

TO BE CONTINUED

PHOTO

PAGE 4 OF 5

**Intertek Testing Services Wuxi Ltd.**

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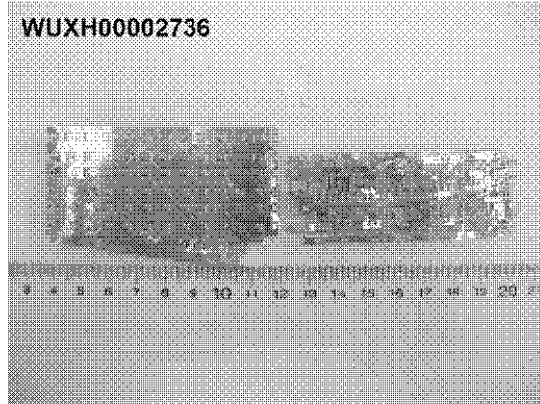
### Annex 3: Analysis Result of Clip (Page 5 of 5)



TEST REPORT

NUMBER: WUXH00002736

TESTS CONDUCTED



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END OF REPORT

PAGE 5 OF 5

**Intertek Testing Services Wuxi Ltd.**  
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**Annex 4: Analysis Result of Matte-Tin plating (page 1 of 7)****Intertek**TEST REPORT

NUMBER: WUXH00002765

APPLICANT: CONCORD SEMICONDUCTOR(WUXI) CO., LTD.  
DATE: AUG 12, 2010  
EAST 1#,ZHENFA 6 ROAD, SHUO FANG  
INDUSTRIAL PARK WUXI NATIONAL HIGH-  
TECH DEVELOPMENT ZONE,  
WUXI,JIANGSU,CHINA  
ATTN: ZHANG XIAOPENG

## SAMPLE DESCRIPTION:

ONE(1)PIECE OF SUBMITTED SAMPLE SAID TO BE :SILVER METAL AND BLACK PLASTIC BODY.

ITEM NAME : TIN PLATING TO-220.  
VENDOR : BANDL (KUNSHAN) INTERNATIONAL CO.,  
COMPONENT OR PART NO. : PURE MATTE TIN.  
TEST ITEM : Pb, Cd, Hg, CrVI, F, Cl, Br, I.

## TESTS CONDUCTED:

AS REQUESTED BY THE APPLICANT, FOR DETAILS REFER TO ATTACHED PAGE(S)

TO BE CONTINUED

PREPARED AND CHECKED BY:  
FOR INTERTEK TESTING SERVICES WUXI LTD.



JESSICA LU  
GENERAL MANAGER

PAGE 1 OF 7

**Intertek Testing Services Wuxi Ltd.**  
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## Annex 4: Analysis Result of Matte-Tin plating (page 2 of 7)


**TEST REPORT**

NUMBER: WUXH00002765

## TESTS CONDUCTED

## (A) TEST RESULT SUMMARY:

TESTING ITEM	RESULT
CADMIUM (Cd) CONTENT (mg/kg)/PLATING	ND
LEAD (Pb) CONTENT (mg/kg)/PLATING	173
MERCURY (Hg) CONTENT (mg/kg)/PLATING	ND
CHROMIUM (VI) (Cr <sup>6+</sup> ) RESULT (BY BOILING WATER EXTRACTION ON METAL) (mg/kg WITH 50cm <sup>2</sup> )	ND

## REMARK:

mg/kg = MILLIGRAM PER KILOGRAM BASED ON DRY WEIGHT= ppm  
 mg/kg WITH 50cm<sup>2</sup> = MILLIGRAM PER KILOGRAM WITH 50 SQUARE CENTIMETER

ND = NOT DETECTED

TEST COMPONENT : SILVER METAL PLATING.

## (B) RoHS REQUIREMENT:

RESTRICTED SUBSTANCES	LIMITS
CADMIUM (Cd)	0.01% (100 mg/kg)
LEAD (Pb)	0.1% (1000 mg/kg)
MERCURY (Hg)	0.1% (1000 mg/kg)
CHROMIUM (VI) (Cr <sup>6+</sup> )	0.1% (1000 mg/kg)

THE ABOVE LIMITS WERE QUOTED FROM 2002/95/EC AND AMENDMENT 2005/618/EC FOR HOMOGENEOUS MATERIAL.

\*\*\*\*\*

TO BE CONTINUED

PAGE 2 OF 7

**Intertek Testing Services Wuxi Ltd.**

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 Wuxi 214101, Jiangsu, China

Tel: +86 510 8821 4567 Fax: +86 510 8820 0428 E-mail: consumergoods.wuxi@intertek.com

## Annex 4: Analysis Result of Matte-Tin plating (page 3 of 7)


**TEST REPORT**

NUMBER: WUXH00002765

## TESTS CONDUCTED

## (c) TEST METHOD:

<u>TESTING ITEM</u>	<u>TESTING METHOD</u>	<u>REPORTING LIMIT</u>
CADMIUM (Cd) CONTENT	WITH REFERENCE TO IEC 62321 EDITION 1.0: 2008, BY ACID DIGESTION AND DETERMINED BY ICP-OES	2 mg/kg
LEAD (Pb) CONTENT	WITH REFERENCE TO IEC 62321 EDITION 1.0: 2008, BY ACID DIGESTION AND DETERMINED BY ICP-OES	2 mg/kg
MERCURY (Hg) CONTENT	WITH REFERENCE TO IEC 62321 EDITION 1.0: 2008, BY ACID DIGESTION AND DETERMINED BY ICP-OES	2 mg/kg
CHROMIUM (VI) (Cr <sup>6+</sup> ) CONTENT (FOR METAL)	WITH REFERENCE TO IEC 62321 EDITION 1.0: 2008, BY BOILING WATER EXTRACTION AND DETERMINED BY UV-VIS SPECTROPHOTOMETER	0.02mg/kg WITH 50cm <sup>2</sup> (IN TESTING SOLUTION)

DATE SAMPLE RECEIVED:AUG 02, 2010

TESTING PERIOD:AUG 02, 2010 TO AUG 05, 2010

\*\*\*\*\*

TO BE CONTINUED

PAGE 3 OF 7

**Intertek Testing Services Wuxi Ltd.**

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## Annex 4: Analysis Result of Matte-Tin plating (page 4 of 7)

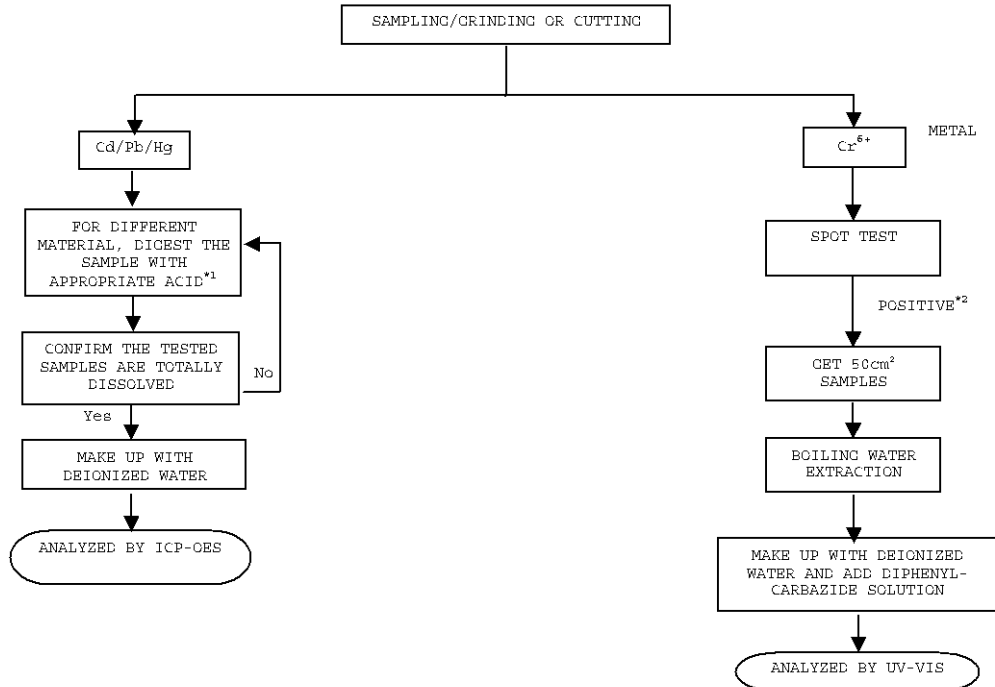
**Intertek**

**TEST REPORT**

NUMBER: WUXH00002765

TESTS CONDUCTED

(D) MEASUREMENT FLOWCHART:  
 TEST FOR Cd/Pb/Hg/Cr (VI) CONTENTS  
 REFERENCE STANDARD: IEC 62321 EDITION 1.0: 2008



CHEMIST: INORGANIC (ANN LUO/FRED WANG/ALLY WAN)

REMARKS:

\*1: LIST OF APPROPRIATE ACID:

MATERIAL	ACID ADDED FOR DIGESTION
POLYMERS	HNO <sub>3</sub> , HCl, HF, H <sub>2</sub> O <sub>2</sub> , H <sub>3</sub> BO <sub>3</sub>
METALS	HNO <sub>3</sub> , HCl, HF
ELECTRONICS	HNO <sub>3</sub> , HCl, H <sub>2</sub> O <sub>2</sub> , HBF <sub>4</sub>

\*2: IF THE RESULT OF SPOT TEST IS POSITIVE, CHROMIUM VI WOULD BE DETERMINED AS DETECTED.

\*\*\*\*\*

TO BE CONTINUED

## Annex 4: Analysis Result of Matte-Tin plating (page 5 of 7)



**TEST REPORT**

NUMBER: WUXH00002765

TESTS CONDUCTED

( I ) TEST RESULT SUMMARY :

HALOGEN CONTENT :

<u>TESTING ITEM</u>	<u>RESULT (ppm)</u>
FLUORINE (F) CONTENT	ND
CHLORINE (Cl) CONTENT	ND
BROMINE (Br) CONTENT	ND
IODINE (I) CONTENT	ND

REMARKS : ppm = PARTS PER MILLION = mg/kg

ND = NOT DETECTED

DATE SAMPLE RECEIVE: AUG 02, 2010

TEST PERIOD: AUG 02, 2010 TO AUG 05, 2010

( II ) TEST METHOD :

<u>TESTING ITEM</u>	<u>TESTING METHOD</u>	<u>REPORTING LIMIT</u>
HALOGEN (F, Cl, Br, I) CONTENT	WITH REFERENCE TO IEC 61189-2:2006 BY COMBUSTION FLASK AND DETERMINED BY ION CHROMATOGRAPHY	50 ppm

REMARKS : REPORTING LIMIT = QUANTITATION LIMIT OF ANALYTE IN SAMPLE

\*\*\*\*\*  
TO BE CONTINUED

PAGE 5 OF 7

**Intertek Testing Services Wuxi Ltd.**

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### Annex 4: Analysis Result of Matte-Tin plating (page 6 of 7)



**TEST REPORT**

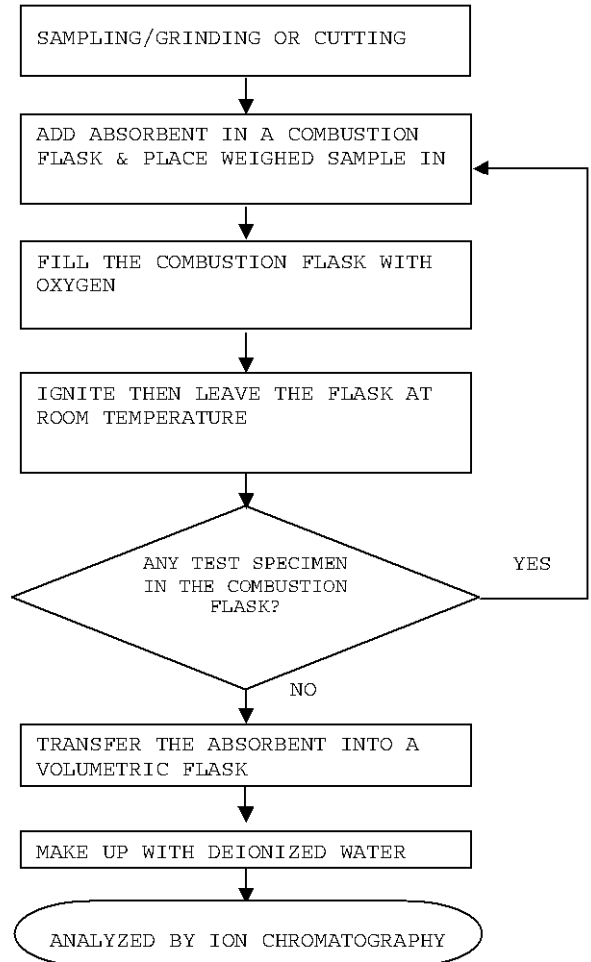
NUMBER: WUXH00002765

TESTS CONDUCTED

(III) MEASUREMENT FLOWCHART:

TEST FOR HALOGEN CONTENT

REFERENCE METHOD: IEC 61189-2 TEST 2C12



CHEMIST: FRED WANG/ ALLY WAN

\*\*\*\*\*  
TO BE CONTINUED

### Annex 4: Analysis Result of Matte-Tin plating (page 7 of 7)

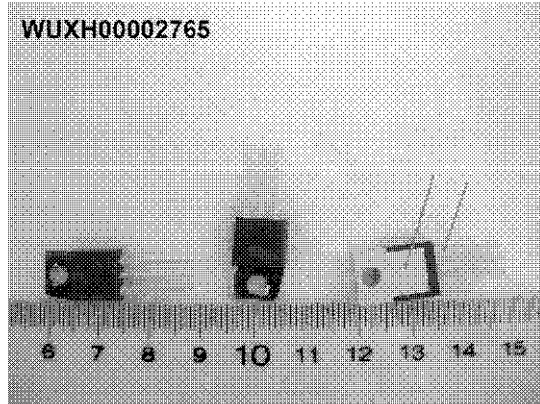


TEST REPORT

NUMBER: WUXH00002765

TESTS CONDUCTED

PHOTO



\*\*\*\*\*

END OF REPORT

PAGE 7 OF 7

**Intertek Testing Services Wuxi Ltd.**  
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**Annex 5: Analysis Result of Ni-plated Wafer (Page 1 of 7)****Intertek**TEST REPORT

NUMBER: WUXH00002719

APPLICANT: CONCORD SEMICONDUCTOR (WUXI) CO., LTD.  
DATE: AUG 06, 2010  
EAST 1#, ZHENFA 6 ROAD, SHUO FANG  
INDUSTRIAL PARK WUXI NATIONAL HIGH-  
TECH DEVELOPMENT ZONE,  
WUXI, JIANGSU, CHINA  
ATTN: ZHANG XIAOPENG

## SAMPLE DESCRIPTION:

ONE (1) PIECE OF SUBMITTED SAMPLE SAID TO BE : **SILVER GREY METAL**.  
ITEM NAME : SILICON WAFER WITH NICKEL PLATING.  
VENDOR : CONCORD.  
COMPONENT OR PART NO. : SILICON+NICKEL.  
TEST ITEM : Pb, Cd, Hg, CrVI, PBB, PBDE, F, Cl, Br, I.

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## TESTS CONDUCTED:

AS REQUESTED BY THE APPLICANT, FOR DETAILS REFER TO ATTACHED PAGE(S)

\*\*\*\*\*

## SUMMARY:

<u>TESTED SAMPLE</u>	<u>STANDARD</u>	<u>RESULT</u>
SUBMITTED SAMPLE	WITH REFERENCE TO TEST METHOD OF IEC 62321 EDITION 1.0: 2008 AND MAXIMUM CONCENTRATION LIMITS QUOTED FROM ROHS DIRECTIVES 2002/95/EC AND AMENDMENT 2005/618/EC	PASS

\*\*\*\*\*

TO BE CONTINUED

PREPARED AND CHECKED BY:  
FOR INTERTEK TESTING SERVICES WUXI LTD.



JESSICA LU  
GENERAL MANAGER

PAGE 1 OF 7

**Intertek Testing Services Wuxi Ltd.**  
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## Annex 5: Analysis Result of Ni-plated Wafer (Page 2 of 7)


**TEST REPORT**

NUMBER: WUXH00002719

## TESTS CONDUCTED

## (A) TEST RESULT SUMMARY:

TESTING ITEM	RESULT
CADMIUM (Cd) CONTENT (mg/kg)	ND
LEAD (Pb) CONTENT (mg/kg)	ND
MERCURY (Hg) CONTENT (mg/kg)	ND
CHROMIUM (VI) (Cr <sup>6+</sup> ) RESULT (BY BOILING WATER EXTRACTION ON METAL) (mg/kg WITH 50cm <sup>2</sup> )	ND
POLYBROMINATED BIPHENYLS (PBBs) (mg/kg)	
MONOBROMO BIPHENYLS (MonoBB)	ND
DIBROMO BIPHENYLS (DiBB)	ND
TRIBROMO BIPHENYLS (TriBB)	ND
TETRABROMO BIPHENYLS (TetraBB)	ND
PENTABROMO BIPHENYLS (PentaBB)	ND
HEXABROMO BIPHENYLS (HexaBB)	ND
HEPTABROMO BIPHENYLS (HeptaBB)	ND
OCTABROMO BIPHENYLS (OctaBB)	ND
NONABROMO BIPHENYLS (NonaBB)	ND
DECABROMO BIPHENYL (DecaBB)	ND
POLYBROMINATED DIPHENYL ETHERS (PBDEs) (mg/kg)	
MONOBROMO DIPHENYL ETHERS (MonoBDE)	ND
DIBROMO DIPHENYL ETHERS (DiBDE)	ND
TRIBROMO DIPHENYL ETHERS (TriBDE)	ND
TETRABROMO DIPHENYL ETHERS (TetraBDE)	ND
PENTABROMO DIPHENYL ETHERS (PentaBDE)	ND
HEXABROMO DIPHENYL ETHERS (HexaBDE)	ND
HEPTABROMO DIPHENYL ETHERS (HeptaBDE)	ND
OCTABROMO DIPHENYL ETHERS (OctaBDE)	ND
NONABROMO DIPHENYL ETHERS (NonaBDE)	ND
DECABROMO DIPHENYL ETHER (DecaBDE)	ND

## REMARK:

mg/kg = MILLIGRAM PER KILOGRAM BASED ON DRY WEIGHT= ppm

ND = NOT DETECTED

 mg/kg WITH 50cm<sup>2</sup> = MILLIGRAM PER KILOGRAM WITH 50 SQUARE CENTIMETER

\*\*\*\*\*

TO BE CONTINUED

PAGE 2 OF 7

**Intertek Testing Services Wuxi Ltd.**

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## Annex 5: Analysis Result of Ni-plated Wafer (Page 3 of 7)


**TEST REPORT**

NUMBER: WUXH00002719

## TESTS CONDUCTED

(B) RoHS REQUIREMENT:

RESTRICTED SUBSTANCES	LIMITS
CADMIUM (Cd)	0.01% (100 mg/kg)
LEAD (Pb)	0.1% (1000 mg/kg)
MERCURY (Hg)	0.1% (1000 mg/kg)
CHROMIUM (VI) (Cr <sup>6+</sup> )	0.1% (1000 mg/kg)
POLYBROMINATED BIPHENYLS (PBBs)	0.1% (1000 mg/kg)
POLYBROMINATED DIPHENYL ETHERS (PBDEs)	0.1% (1000 mg/kg)

THE ABOVE LIMITS WERE QUOTED FROM 2002/95/EC AND AMENDMENT 2005/618/EC FOR HOMOGENEOUS MATERIAL.

(c) TEST METHOD:

TESTING ITEM	TESTING METHOD	REPORTING LIMIT
CADMIUM (Cd) CONTENT	WITH REFERENCE TO IEC 62321 EDITION 1.0: 2008, BY ACID DIGESTION AND DETERMINED BY ICP-OES	2 mg/kg
LEAD (Pb) CONTENT	WITH REFERENCE TO IEC 62321 EDITION 1.0: 2008, BY ACID DIGESTION AND DETERMINED BY ICP-OES	2 mg/kg
MERCURY (Hg) CONTENT	WITH REFERENCE TO IEC 62321 EDITION 1.0: 2008, BY ACID DIGESTION AND DETERMINED BY ICP-OES	2 mg/kg
CHROMIUM (VI) (Cr <sup>6+</sup> ) CONTENT (FOR METAL)	WITH REFERENCE TO IEC 62321 EDITION 1.0: 2008, BY BOILING WATER EXTRACTION AND DETERMINED BY UV-VIS SPECTROPHOTOMETER	0.02mg/kg WITH 50cm <sup>2</sup> (IN TESTING SOLUTION)
POLYBROMINATED BIPHENYLS (PBBs) & POLYBROMINATED DIPHENYL ETHERS (PBDEs)	WITH REFERENCE TO IEC IEC 62321 EDITION 1.0: 2008, BY SOLVENT EXTRACTION AND DETERMINED BY GC/MS AND FURTHER HPLC CONFIRMATION WHEN NECESSARY.	5 mg/kg

DATE SAMPLE RECEIVED:AUG 02, 2010

TESTING PERIOD:AUG 02, 2010 TO AUG 05, 2010

\*\*\*\*\*

TO BE CONTINUED

PAGE 3 OF 7

**Intertek Testing Services Wuxi Ltd.**

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## Annex 5: Analysis Result of Ni-plated Wafer (Page 4 of 7)

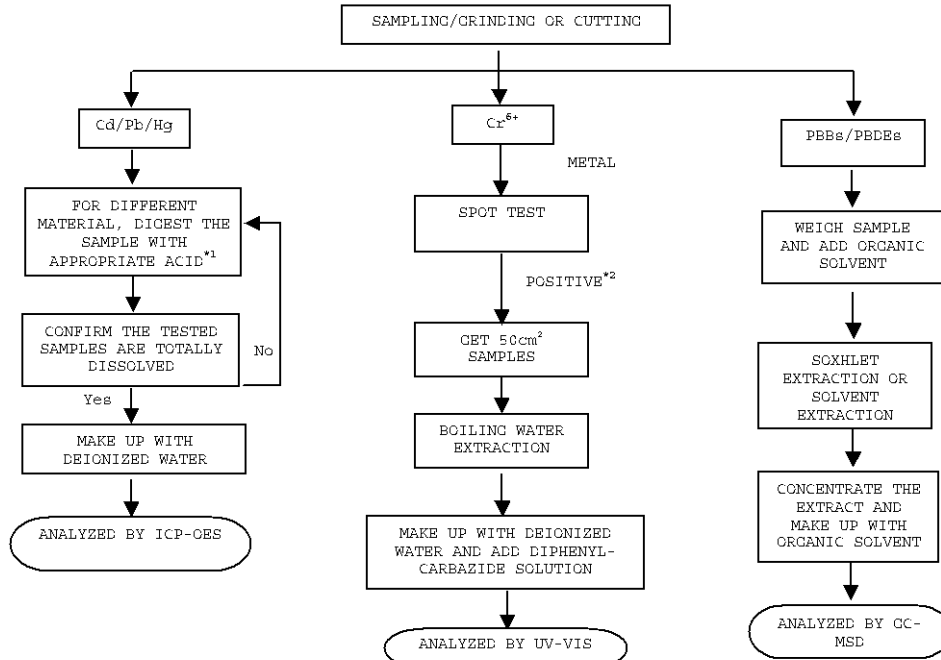


### TEST REPORT

NUMBER: WUXH00002719

#### TESTS CONDUCTED

(D) MEASUREMENT FLOWCHART:

 TEST FOR Cd/Pb/Hg/Cr (VI)/PBBs/PBDEs CONTENTS  
 REFERENCE STANDARD: IEC 62321 EDITION 1.0: 2008

 CHEMIST: INORGANIC (ANN LUO/FRED WANG/ALLY WAN)  
 ORGANIC (JENNY XU/CHERRY SUN)

#### REMARKS:

\*1: LIST OF APPROPRIATE ACID:

MATERIAL	ACID ADDED FOR DIGESTION
POLYMERS	HNO <sub>3</sub> , HCl, HF, H <sub>2</sub> O <sub>2</sub> , H <sub>3</sub> BO <sub>3</sub>
METALS	HNO <sub>3</sub> , HCl, HF
ELECTRONICS	HNO <sub>3</sub> , HCl, H <sub>2</sub> O <sub>2</sub> , HBF <sub>4</sub>

\*2: IF THE RESULT OF SPOT TEST IS POSITIVE, CHROMIUM VI WOULD BE DETERMINED AS DETECTED.

\*\*\*\*\*

TO BE CONTINUED

PAGE 4 OF 7

**Intertek Testing Services Wuxi Ltd.**

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## Annex 5: Analysis Result of Ni-plated Wafer (Page 5 of 7)


**TEST REPORT**

NUMBER: WUXH00002719

## TESTS CONDUCTED

## ( I ) TEST RESULT SUMMARY :

## HALOGEN CONTENT :

TESTING ITEM	RESULT (ppm)
FLUORINE (F) CONTENT	ND
CHLORINE (Cl) CONTENT	ND
BROMINE (Br) CONTENT	ND
IODINE (I) CONTENT	ND

REMARKS : ppm = PARTS PER MILLION = mg/kg

ND = NOT DETECTED

DATE SAMPLE RECEIVE: AUG 02, 2010

TEST PERIOD: AUG 02, 2010 TO AUG 05, 2010

## ( II ) TEST METHOD :

TESTING ITEM	TESTING METHOD	REPORTING LIMIT
HALOGEN (F, Cl, Br, I) CONTENT	WITH REFERENCE TO IEC 61189-2:2006 BY COMBUSTION FLASK AND DETERMINED BY ION CHROMATOGRAPHY	50 ppm

REMARKS : REPORTING LIMIT = QUANTITATION LIMIT OF ANALYTE IN SAMPLE

 \*\*\*\*\*  
 TO BE CONTINUED

PAGE 5 OF 7

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**Annex 5: Analysis Result of Ni-plated Wafer (Page 6 of 7)**



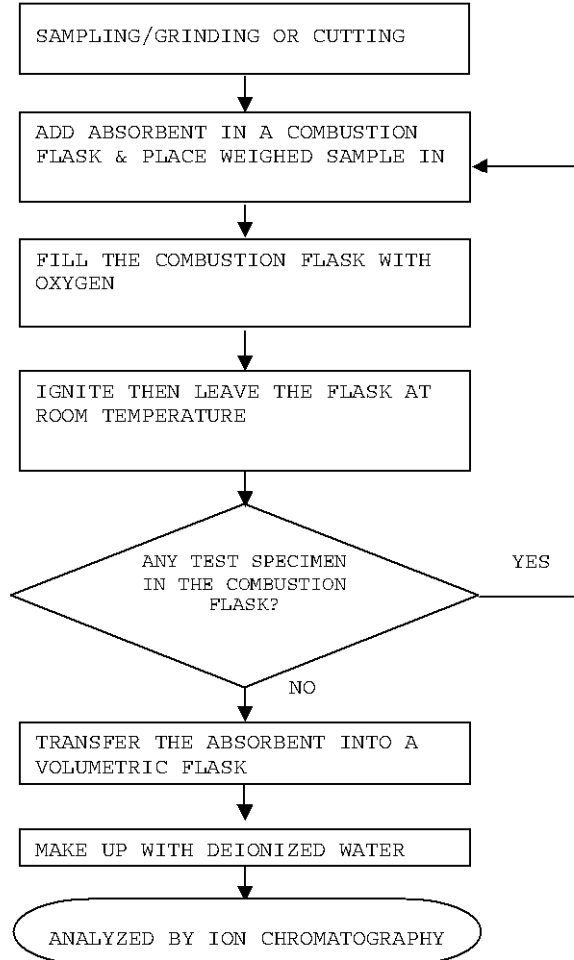
**TEST REPORT**

NUMBER: WUXH00002719

TESTS CONDUCTED

(III) MEASUREMENT FLOWCHART:

TEST FOR HALOGEN CONTENT  
REFERENCE METHOD: IEC 61189-2 TEST 2C12



CHEMIST: FRED WANG/ ALLY WAN

\*\*\*\*\*  
TO BE CONTINUED

### Annex 5: Analysis Result of Ni-plated Wafer (Page 7 of 7)

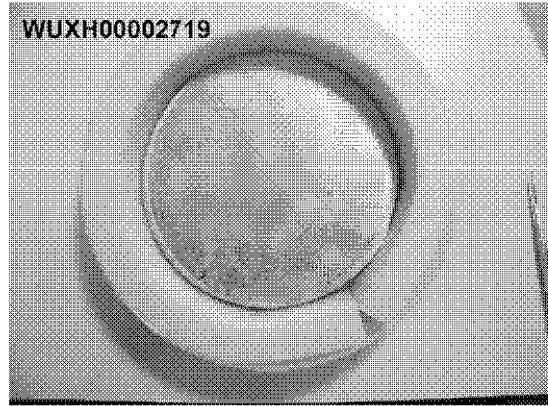


TEST REPORT

NUMBER: WUXH00002719

TESTS CONDUCTED

PHOTO



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END OF REPORT

PAGE 7 OF 7

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**Annex 6: Analysis Result of Passivation Glass (Page 1 of 7)****TEST REPORT**

NUMBER: WUXH00002721

APPLICANT: CONCORD SEMICONDUCTOR (WUXI) CO., LTD.  
DATE: AUG 06, 2010  
EAST 1#, ZHENFA 6 ROAD, SHUO FANG  
INDUSTRIAL PARK WUXI NATIONAL HIGH-  
TECH DEVELOPMENT ZONE,  
WUXI, JIANGSU, CHINA  
ATTN: ZHANG XIAOPENG

## SAMPLE DESCRIPTION:

ONE (1) PIECE OF SUBMITTED SAMPLE SAID TO BE :WHITE POWDER.  
ITEM NAME : WAFER PASSIVATION.  
VENDOR : PROPRIETY.  
COMPONENT OR PART NO. : PROPRIETY.  
TEST ITEM : Pb, Cd, Hg, CrVI, PBB, PBDE, F, Cl, Br, I.

\*\*\*\*\*

## TESTS CONDUCTED:

AS REQUESTED BY THE APPLICANT, FOR DETAILS REFER TO ATTACHED PAGE(S)

\*\*\*\*\*

TO BE CONTINUED

PREPARED AND CHECKED BY:  
FOR INTERTEK TESTING SERVICES WUXI LTD.



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GENERAL MANAGER

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PAGE 1 OF 7

## Annex 6: Analysis Result of Passivation Glass (Page 2 of 7)


**TEST REPORT**

NUMBER: WUXH00002721

## TESTS CONDUCTED

## (A) TEST RESULT SUMMARY:

TESTING ITEM	RESULT
CADMIUM (Cd) CONTENT (mg/kg)	ND
LEAD (Pb) CONTENT (mg/kg)	207400
MERCURY (Hg) CONTENT (mg/kg)	ND
CHROMIUM (VI) (Cr <sup>6+</sup> ) CONTENT (mg/kg) (FOR NON-METAL)	ND
POLYBROMINATED BIPHENYLS (PBBs) (mg/kg)	
MONOBROMO BIPHENYLS (MonoBB)	ND
DIBROMO BIPHENYLS (DiBB)	ND
TRIBROMO BIPHENYLS (TriBB)	ND
TETRABROMO BIPHENYLS (TetraBB)	ND
PENTABROMO BIPHENYLS (PentaBB)	ND
HEXABROMO BIPHENYLS (HexaBB)	ND
HEPTABROMO BIPHENYLS (HeptaBB)	ND
OCTABROMO BIPHENYLS (OctaBB)	ND
NONABROMO BIPHENYLS (NonaBB)	ND
DECABROMO BIPHENYL (DecaBB)	ND
POLYBROMINATED DIPHENYL ETHERS (PBDEs) (mg/kg)	
MONOBROMO DIPHENYL ETHERS (MonoBDE)	ND
DIBROMO DIPHENYL ETHERS (DiBDE)	ND
TRIBROMO DIPHENYL ETHERS (TriBDE)	ND
TETRABROMO DIPHENYL ETHERS (TetraBDE)	ND
PENTABROMO DIPHENYL ETHERS (PentaBDE)	ND
HEXABROMO DIPHENYL ETHERS (HexaBDE)	ND
HEPTABROMO DIPHENYL ETHERS (HeptaBDE)	ND
OCTABROMO DIPHENYL ETHERS (OctaBDE)	ND
NONABROMO DIPHENYL ETHERS (NonaBDE)	ND
DECABROMO DIPHENYL ETHER (DecaBDE)	ND

## REMARK:

mg/kg = MILLIGRAM PER KILOGRAM BASED ON DRY WEIGHT= ppm

ND = NOT DETECTED

# = THE RESULT IS FOR REFERENCE ONLY

 \*\*\*\*\*  
 TO BE CONTINUED

PAGE 2 OF 7

**Intertek Testing Services Wuxi Ltd.**

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## Annex 6: Analysis Result of Passivation Glass (Page 3 of 7)


**TEST REPORT**

NUMBER: WUXH00002721

## TESTS CONDUCTED

## (B) RoHS REQUIREMENT:

RESTRICTED SUBSTANCES	LIMITS
CADMIUM (Cd)	0.01% (100 mg/kg)
LEAD (Pb)	0.1% (1000 mg/kg)
MERCURY (Hg)	0.1% (1000 mg/kg)
CHROMIUM (VI) (Cr <sup>6+</sup> )	0.1% (1000 mg/kg)
POLYBROMINATED BIPHENYLS (PBBs)	0.1% (1000 mg/kg)
POLYBROMINATED DIPHENYL ETHERS (PBDEs)	0.1% (1000 mg/kg)

THE ABOVE LIMITS WERE QUOTED FROM 2002/95/EC AND AMENDMENT 2005/618/EC FOR HOMOGENEOUS MATERIAL.

## (c) TEST METHOD:

TESTING ITEM	TESTING METHOD	REPORTING LIMIT
CADMIUM (Cd) CONTENT	WITH REFERENCE TO IEC 62321 EDITION 1.0: 2008, BY ACID DIGESTION AND DETERMINED BY ICP-OES	2 mg/kg
LEAD (Pb) CONTENT	WITH REFERENCE TO IEC 62321 EDITION 1.0: 2008, BY ACID DIGESTION AND DETERMINED BY ICP-OES	2 mg/kg
MERCURY (Hg) CONTENT	WITH REFERENCE TO IEC 62321 EDITION 1.0: 2008, BY ACID DIGESTION AND DETERMINED BY ICP-OES	2 mg/kg
CHROMIUM (VI) (Cr <sup>6+</sup> ) CONTENT (FOR NON-METAL)	WITH REFERENCE TO IEC 62321 EDITION 1.0: 2008, BY ALKALINE DIGESTION AND DETERMINED BY UV-VIS SPECTROPHOTOMETER	1 mg/kg
POLYBROMINATED BIPHENYLS (PBBs) & POLYBROMINATED DIPHENYL ETHERS (PBDEs)	WITH REFERENCE TO IEC IEC 62321 EDITION 1.0: 2008, BY SOLVENT EXTRACTION AND DETERMINED BY GC/MS AND FURTHER HPLC CONFIRMATION WHEN NECESSARY.	5 mg/kg

DATE SAMPLE RECEIVED: AUG 02, 2010

TESTING PERIOD: AUG 02, 2010 TO AUG 05, 2010

\*\*\*\*\*

TO BE CONTINUED

PAGE 3 OF 7

**Intertek Testing Services Wuxi Ltd.**

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## Annex 6: Analysis Result of Passivation Glass (Page 4 of 7)

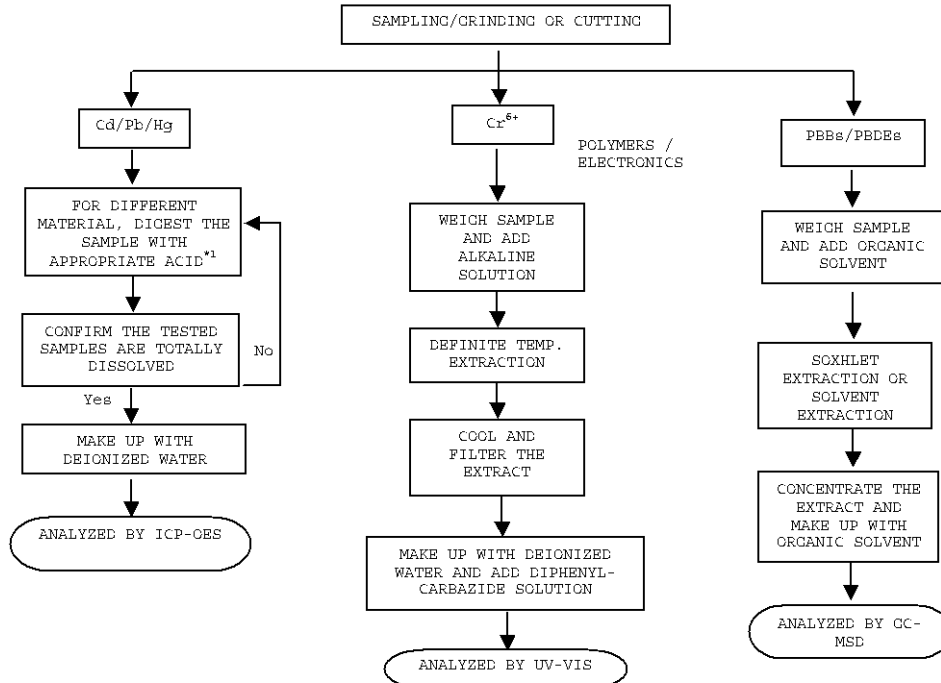


### TEST REPORT

NUMBER: WUXH00002721

#### TESTS CONDUCTED

(D) MEASUREMENT FLOWCHART:  
 TEST FOR Cd/Pb/Hg/Cr (VI)/PBBs/PBDEs CONTENTS  
 REFERENCE STANDARD: IEC 62321 EDITION 1.0: 2008



CHEMIST: INORGANIC (ANN LUO/FRED WANG/ALLY WAN)  
 ORGANIC (JENNY XU/CHERRY SUN)

#### REMARKS:

\*1: LIST OF APPROPRIATE ACID:

MATERIAL	ACID ADDED FOR DIGESTION
POLYMERS	HNO <sub>3</sub> , HCl, HF, H <sub>2</sub> O <sub>2</sub> , H <sub>3</sub> BO <sub>3</sub>
METALS	HNO <sub>3</sub> , HCl, HF
ELECTRONICS	HNO <sub>3</sub> , HCl, H <sub>2</sub> O <sub>2</sub> , HBF <sub>4</sub>

\*2: IF THE RESULT OF SPOT TEST IS POSITIVE, CHROMIUM VI WOULD BE DETERMINED AS DETECTED.

\*\*\*\*\*

TO BE CONTINUED

PAGE 4 OF 7

**Intertek Testing Services Wuxi Ltd.**

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## Annex 6: Analysis Result of Passivation Glass (Page 5 of 7)



**TEST REPORT**

NUMBER: WUXH00002721

TESTS CONDUCTED

( I ) TEST RESULT SUMMARY :

HALOGEN CONTENT :

<u>TESTING ITEM</u>	<u>RESULT (ppm)</u>
FLUORINE (F) CONTENT	ND
CHLORINE (Cl) CONTENT	ND
BROMINE (Br) CONTENT	ND
IODINE (I) CONTENT	ND

REMARKS : ppm = PARTS PER MILLION = mg/kg

ND = NOT DETECTED

DATE SAMPLE RECEIVE: AUG 02, 2010

TEST PERIOD: AUG 02, 2010 TO AUG 05, 2010

( II ) TEST METHOD :

<u>TESTING ITEM</u>	<u>TESTING METHOD</u>	<u>REPORTING LIMIT</u>
HALOGEN (F, Cl, Br, I) CONTENT	WITH REFERENCE TO IEC 61189-2:2006 BY COMBUSTION FLASK AND DETERMINED BY ION CHROMATOGRAPHY	50 ppm

REMARKS : REPORTING LIMIT = QUANTITATION LIMIT OF ANALYTE IN SAMPLE

\*\*\*\*\*  
TO BE CONTINUED

PAGE 5 OF 7

**Intertek Testing Services Wuxi Ltd.**

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**Annex 6: Analysis Result of Passivation Glass (Page 6 of 7)**



**TEST REPORT**

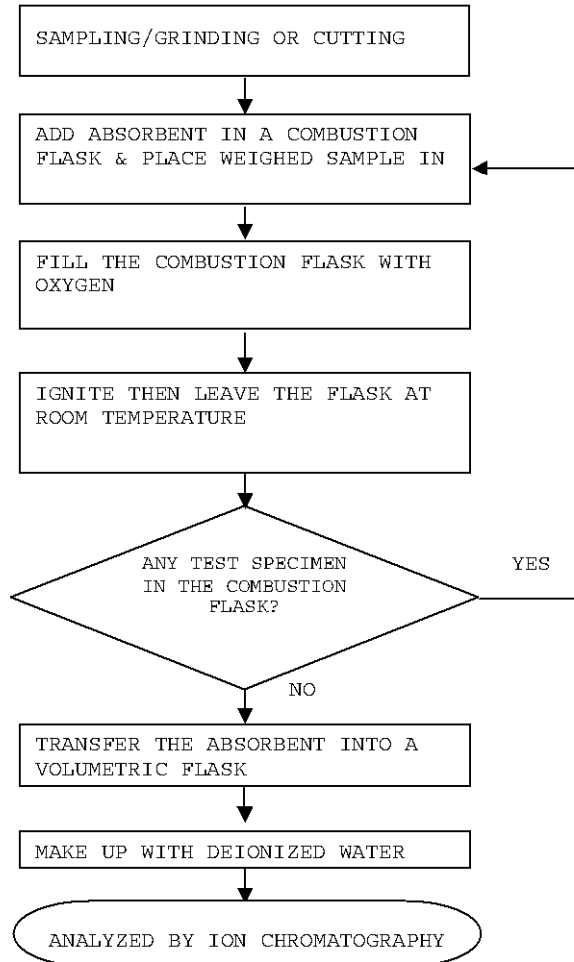
NUMBER: WUXH00002721

TESTS CONDUCTED

(III) MEASUREMENT FLOWCHART:

TEST FOR HALOGEN CONTENT

REFERENCE METHOD: IEC 61189-2 TEST 2C12



CHEMIST: FRED WANG/ ALLY WAN

\*\*\*\*\*  
TO BE CONTINUED

**Annex 6: Analysis Result of Passivation Glass (Page 7 of 7)**



TEST REPORT

NUMBER: WUXH00002721

TESTS CONDUCTED

PHOTO



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END OF REPORT

PAGE 7 OF 7

**Intertek Testing Services Wuxi Ltd.**  
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**Annex 7: Analysis Result of Die Bonding Solder (Page 1 of 7)****TEST REPORT**

NUMBER: WUXH00002748

APPLICANT: CONCORD SEMICONDUCTOR (WUXI) CO., LTD.  
DATE: AUG 12, 2010  
EAST 1#, ZHENFA 6 ROAD, SHUO FANG  
INDUSTRIAL PARK WUXI NATIONAL HIGH-  
TECH DEVELOPMENT ZONE,  
WUXI, JIANGSU, CHINA  
ATTN: ZHANG XIAOPENG

**SAMPLE DESCRIPTION:**ONE (1) PIECE OF SUBMITTED SAMPLE SAID TO BE : **GREY PASTE.**

ITEM NAME : SOLDER PASTER.  
VENDOR : HERAEUS MATERIALS TECHNOLOGY SHANGHAI LTD.  
COMPONENT OR PART NO. : CL30-9690.  
TEST ITEM : Pb, Cd, Hg, CrVI, PBB, PBDE, F, Cl, Br, I.

\*\*\*\*\*

**TESTS CONDUCTED:**

AS REQUESTED BY THE APPLICANT, FOR DETAILS REFER TO ATTACHED PAGE(S)

\*\*\*\*\*

TO BE CONTINUED

PREPARED AND CHECKED BY:  
FOR INTERTEK TESTING SERVICES WUXI LTD.



JESSICA LU  
GENERAL MANAGER

PAGE 1 OF 7

**Intertek Testing Services Wuxi Ltd.**  
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## Annex 7: Analysis Result of Die Bonding Solder (Page 2 of 7)


**TEST REPORT**

NUMBER: WUXH00002748

## TESTS CONDUCTED

## (A) TEST RESULT SUMMARY:

TESTING ITEM	RESULT
CADMIUM (Cd) CONTENT (mg/kg)	ND
LEAD (Pb) CONTENT (mg/kg)	868900
MERCURY (Hg) CONTENT (mg/kg)	ND
CHROMIUM (VI) (Cr <sup>6+</sup> ) CONTENT (mg/kg) (FOR NON-METAL)	ND
POLYBROMINATED BIPHENYLS (PBBs) (mg/kg)	
MONOBROMO BIPHENYLS (MonoBB)	ND
DIBROMO BIPHENYLS (DiBB)	ND
TRIBROMO BIPHENYLS (TriBB)	ND
TETRABROMO BIPHENYLS (TetraBB)	ND
PENTABROMO BIPHENYLS (PentaBB)	ND
HEXABROMO BIPHENYLS (HexaBB)	ND
HEPTABROMO BIPHENYLS (HeptaBB)	ND
OCTABROMO BIPHENYLS (OctaBB)	ND
NONABROMO BIPHENYLS (NonaBB)	ND
DECABROMO BIPHENYL (DecaBB)	ND
POLYBROMINATED DIPHENYL ETHERS (PBDEs) (mg/kg)	
MONOBROMO DIPHENYL ETHERS (MonoBDE)	ND
DIBROMO DIPHENYL ETHERS (DiBDE)	ND
TRIBROMO DIPHENYL ETHERS (TriBDE)	ND
TETRABROMO DIPHENYL ETHERS (TetraBDE)	ND
PENTABROMO DIPHENYL ETHERS (PentaBDE)	ND
HEXABROMO DIPHENYL ETHERS (HexaBDE)	ND
HEPTABROMO DIPHENYL ETHERS (HeptaBDE)	ND
OCTABROMO DIPHENYL ETHERS (OctaBDE)	ND
NONABROMO DIPHENYL ETHERS (NonaBDE)	ND
DECABROMO DIPHENYL ETHER (DecaBDE)	ND

## REMARK:

mg/kg = MILLIGRAM PER KILOGRAM BASED ON DRY WEIGHT= ppm

ND = NOT DETECTED

# = THE RESULT IS FOR REFERENCE ONLY

 \*\*\*\*\*  
 TO BE CONTINUED

PAGE 2 OF 7

**Intertek Testing Services Wuxi Ltd.**

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## Annex 7: Analysis Result of Die Bonding Solder (Page 3 of 7)


**TEST REPORT**

NUMBER: WUXH00002748

## TESTS CONDUCTED

## (B) RoHS REQUIREMENT:

RESTRICTED SUBSTANCES	LIMITS
CADMIUM (Cd)	0.01% (100 mg/kg)
LEAD (Pb)	0.1% (1000 mg/kg)
MERCURY (Hg)	0.1% (1000 mg/kg)
CHROMIUM (VI) (Cr <sup>6+</sup> )	0.1% (1000 mg/kg)
POLYBROMINATED BIPHENYLS (PBBs)	0.1% (1000 mg/kg)
POLYBROMINATED DIPHENYL ETHERS (PBDEs)	0.1% (1000 mg/kg)

THE ABOVE LIMITS WERE QUOTED FROM 2002/95/EC AND AMENDMENT 2005/618/EC FOR HOMOGENEOUS MATERIAL.

## (c) TEST METHOD:

TESTING ITEM	TESTING METHOD	REPORTING LIMIT
CADMIUM (Cd) CONTENT	WITH REFERENCE TO IEC 62321 EDITION 1.0: 2008, BY ACID DIGESTION AND DETERMINED BY ICP-OES	2 mg/kg
LEAD (Pb) CONTENT	WITH REFERENCE TO IEC 62321 EDITION 1.0: 2008, BY ACID DIGESTION AND DETERMINED BY ICP-OES	2 mg/kg
MERCURY (Hg) CONTENT	WITH REFERENCE TO IEC 62321 EDITION 1.0: 2008, BY ACID DIGESTION AND DETERMINED BY ICP-OES	2 mg/kg
CHROMIUM (VI) (Cr <sup>6+</sup> ) CONTENT (FOR NON-METAL)	WITH REFERENCE TO IEC 62321 EDITION 1.0: 2008, BY ALKALINE DIGESTION AND DETERMINED BY UV-VIS SPECTROPHOTOMETER	1 mg/kg
POLYBROMINATED BIPHENYLS (PBBs) & POLYBROMINATED DIPHENYL ETHERS (PBDEs)	WITH REFERENCE TO IEC IEC 62321 EDITION 1.0: 2008, BY SOLVENT EXTRACTION AND DETERMINED BY GC/MS AND FURTHER HPLC CONFIRMATION WHEN NECESSARY.	5 mg/kg

DATE SAMPLE RECEIVED:AUG 02, 2010

TESTING PERIOD:AUG 02, 2010 TO AUG 05, 2010

\*\*\*\*\*

TO BE CONTINUED

PAGE 3 OF 7

**Intertek Testing Services Wuxi Ltd.**

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## Annex 7: Analysis Result of Die Bonding Solder (Page 4 of 7)

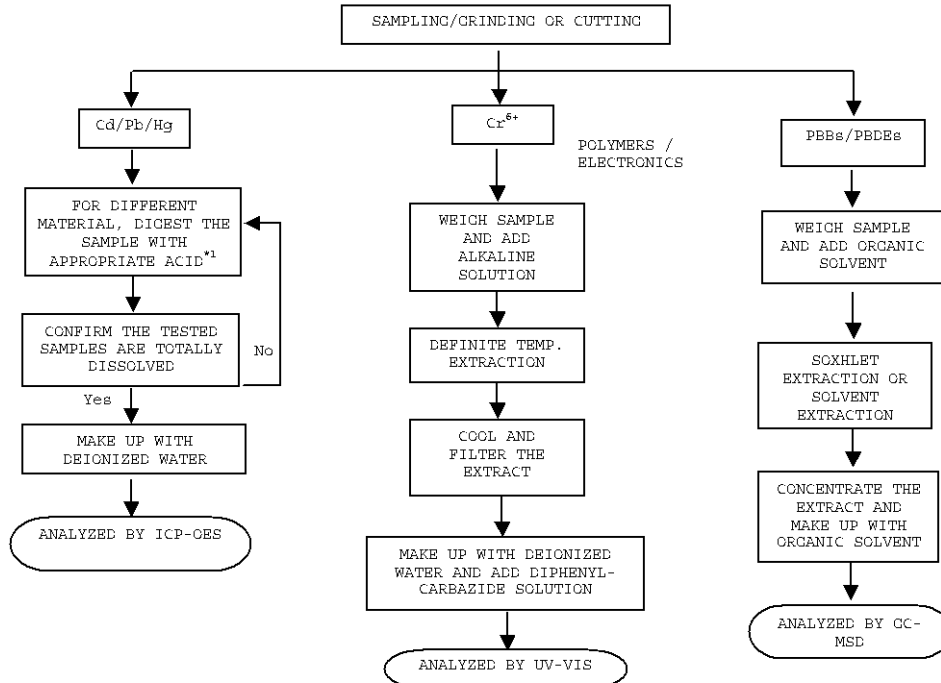


### TEST REPORT

NUMBER: WUXH00002748

#### TESTS CONDUCTED

(D) MEASUREMENT FLOWCHART:  
 TEST FOR Cd/Pb/Hg/Cr (VI)/PBBs/PBDEs CONTENTS  
 REFERENCE STANDARD: IEC 62321 EDITION 1.0: 2008



CHEMIST: INORGANIC (ANN LUO/FRED WANG/ALLY WAN)  
 ORGANIC (JENNY XU/CHERRY SUN)

#### REMARKS:

\*1: LIST OF APPROPRIATE ACID:

MATERIAL	ACID ADDED FOR DIGESTION
POLYMERS	HNO <sub>3</sub> , HCl, HF, H <sub>2</sub> O <sub>2</sub> , H <sub>3</sub> BO <sub>3</sub>
METALS	HNO <sub>3</sub> , HCl, HF
ELECTRONICS	HNO <sub>3</sub> , HCl, H <sub>2</sub> O <sub>2</sub> , HBF <sub>4</sub>

\*2: IF THE RESULT OF SPOT TEST IS POSITIVE, CHROMIUM VI WOULD BE DETERMINED AS DETECTED.

\*\*\*\*\*

TO BE CONTINUED

PAGE 4 OF 7

**Intertek Testing Services Wuxi Ltd.**

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## Annex 7: Analysis Result of Die Bonding Solder (Page 5 of 7)



**TEST REPORT**

NUMBER: WUXH00002748

TESTS CONDUCTED

( I ) TEST RESULT SUMMARY :

HALOGEN CONTENT :

<u>TESTING ITEM</u>	<u>RESULT (ppm)</u>
FLUORINE (F) CONTENT	ND
CHLORINE (Cl) CONTENT	ND
BROMINE (Br) CONTENT	ND
IODINE (I) CONTENT	ND

REMARKS : ppm = PARTS PER MILLION = mg/kg

ND = NOT DETECTED

DATE SAMPLE RECEIVE: AUG 02, 2010

TEST PERIOD: AUG 02, 2010 TO AUG 05, 2010

( II ) TEST METHOD :

<u>TESTING ITEM</u>	<u>TESTING METHOD</u>	<u>REPORTING LIMIT</u>
HALOGEN (F, Cl, Br, I) CONTENT	WITH REFERENCE TO IEC 61189-2:2006 BY COMBUSTION FLASK AND DETERMINED BY ION CHROMATOGRAPHY	50 ppm

REMARKS : REPORTING LIMIT = QUANTITATION LIMIT OF ANALYTE IN SAMPLE

\*\*\*\*\*  
TO BE CONTINUED

PAGE 5 OF 7

**Intertek Testing Services Wuxi Ltd.**

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**Annex 7: Analysis Result of Die Bonding Solder (Page 6 of 7)**



**TEST REPORT**

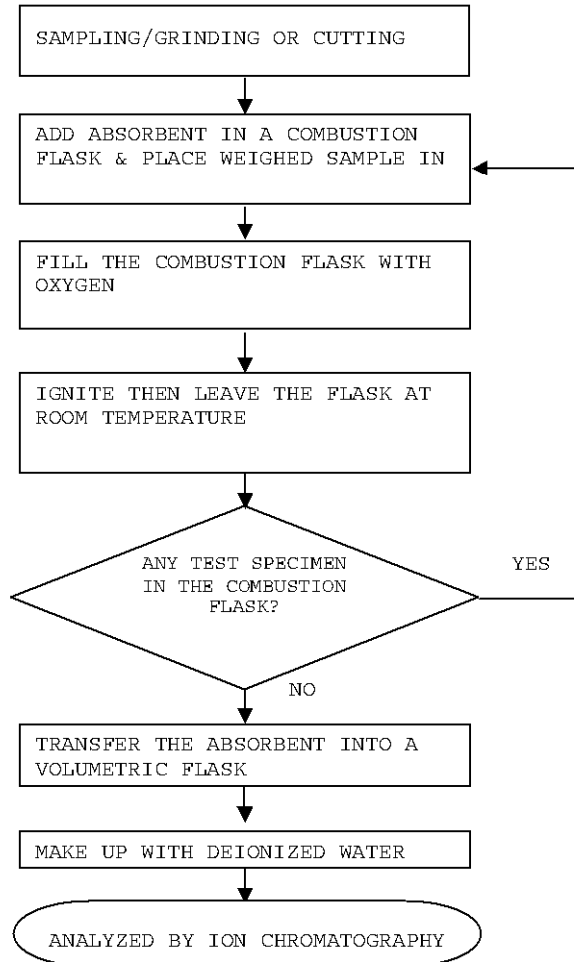
NUMBER: WUXH00002748

TESTS CONDUCTED

(III) MEASUREMENT FLOWCHART:

TEST FOR HALOGEN CONTENT

REFERENCE METHOD: IEC 61189-2 TEST 2C12



CHEMIST: FRED WANG/ ALLY WAN

\*\*\*\*\*  
TO BE CONTINUED

## Annex 7: Analysis Result of Die Bonding Solder (Page 7 of 7)

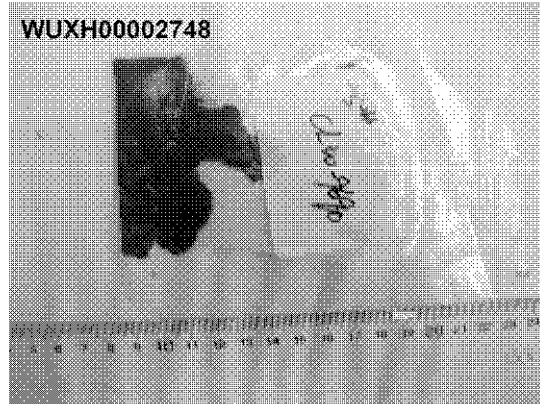


TEST REPORT

NUMBER: WUXH00002748

TESTS CONDUCTED

PHOTO



\*\*\*\*\*

END OF REPORT

PAGE 7 OF 7

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**Annex 8: Analysis Result of Ceramic Substrate (Page 1 of 5)****Intertek****TEST REPORT**

NUMBER: WUXH00002764

APPLICANT: CONCORD SEMICONDUCTOR(WUXI) CO.,LTD. DATE: AUG 06, 2010  
EAST 1#,ZHENFA 6 ROAD, SHUO FANG  
INDUSTRIAL PARK WUXI NATIONAL HIGH-  
TECH DEVELOPMENT ZONE,  
WUXI,JIANGSU,CHINA  
ATTN: ZHANG XIAOPENG

## SAMPLE DESCRIPTION:

ONE (1)PIECE OF SUBMITTED SAMPLE SAID TO BE :**GREY CERAMIC.**  
ITEM NAME : CERAMIC.  
VENDOR : CERAMTEC AG.  
COMPONENT OR PART NO. : CERAMIC.  
TEST ITEM : Pb,Cd,Hg,CrVI,PBB PBDE.  
TEST MODE : AS PER CLIENT'S REQUEST, THE TESTED SAMPLE  
WAS TESTED AS A WHOLE AND SAMPLED.

\*\*\*\*\*  
TESTS CONDUCTED:

AS REQUESTED BY THE APPLICANT, FOR DETAILS REFER TO ATTACHED PAGE(S)  
\*\*\*\*\*  
TO BE CONTINUED

PREPARED AND CHECKED BY:  
FOR INTERTEK TESTING SERVICES WUXI LTD.



JESSICA LU  
GENERAL MANAGER

**Intertek Testing Services Wuxi Ltd.**  
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PAGE 1 OF 5

## Annex 8: Analysis Result of Ceramic Substrate (Page 2 of 5)


**TEST REPORT**

NUMBER: WUXH00002764

## TESTS CONDUCTED

## (A) TEST RESULT SUMMARY:

TESTING ITEM	RESULT
CADMIUM (Cd) CONTENT (mg/kg)	ND
LEAD (Pb) CONTENT (mg/kg)	ND
MERCURY (Hg) CONTENT (mg/kg)	ND
CHROMIUM (VI) (Cr <sup>6+</sup> ) CONTENT (mg/kg) (FOR NON-METAL)	ND
POLYBROMINATED BIPHENYLS (PBBs) (mg/kg)	
MONOBROMO BIPHENYLS (MonoBB)	ND
DIBROMO BIPHENYLS (DiBB)	ND
TRIBROMO BIPHENYLS (TriBB)	ND
TETRABROMO BIPHENYLS (TetraBB)	ND
PENTABROMO BIPHENYLS (PentaBB)	ND
HEXABROMO BIPHENYLS (HexaBB)	ND
HEPTABROMO BIPHENYLS (HeptaBB)	ND
OCTABROMO BIPHENYLS (OctaBB)	ND
NONABROMO BIPHENYLS (NonaBB)	ND
DECABROMO BIPHENYL (DecaBB)	ND
POLYBROMINATED DIPHENYL ETHERS (PBDEs) (mg/kg)	
MONOBROMO DIPHENYL ETHERS (MonoBDE)	ND
DIBROMO DIPHENYL ETHERS (DiBDE)	ND
TRIBROMO DIPHENYL ETHERS (TriBDE)	ND
TETRABROMO DIPHENYL ETHERS (TetraBDE)	ND
PENTABROMO DIPHENYL ETHERS (PentaBDE)	ND
HEXABROMO DIPHENYL ETHERS (HexaBDE)	ND
HEPTABROMO DIPHENYL ETHERS (HeptaBDE)	ND
OCTABROMO DIPHENYL ETHERS (OctaBDE)	ND
NONABROMO DIPHENYL ETHERS (NonaBDE)	ND
DECABROMO DIPHENYL ETHER (DecaBDE)	ND

## REMARK:

mg/kg = MILLIGRAM PER KILOGRAM BASED ON DRY WEIGHT= ppm

ND = NOT DETECTED

\*\*\*\*\*

TO BE CONTINUED

PAGE 2 OF 5

**Intertek Testing Services Wuxi Ltd.**

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## Annex 8: Analysis Result of Ceramic Substrate (Page 3 of 5)


**TEST REPORT**

NUMBER: WUXH00002764

## TESTS CONDUCTED

(B) RoHS REQUIREMENT:

RESTRICTED SUBSTANCES	LIMITS
CADMIUM (Cd)	0.01% (100 mg/kg)
LEAD (Pb)	0.1% (1000 mg/kg)
MERCURY (Hg)	0.1% (1000 mg/kg)
CHROMIUM (VI) (Cr <sup>6+</sup> )	0.1% (1000 mg/kg)
POLYBROMINATED BIPHENYLS (PBBs)	0.1% (1000 mg/kg)
POLYBROMINATED DIPHENYL ETHERS (PBDEs)	0.1% (1000 mg/kg)

THE ABOVE LIMITS WERE QUOTED FROM 2002/95/EC AND AMENDMENT 2005/618/EC FOR HOMOGENEOUS MATERIAL.

(c) TEST METHOD:

TESTING ITEM	TESTING METHOD	REPORTING LIMIT
CADMIUM (Cd) CONTENT	WITH REFERENCE TO IEC 62321 EDITION 1.0: 2008, BY ACID DIGESTION AND DETERMINED BY ICP-OES	2 mg/kg
LEAD (Pb) CONTENT	WITH REFERENCE TO IEC 62321 EDITION 1.0: 2008, BY ACID DIGESTION AND DETERMINED BY ICP-OES	2 mg/kg
MERCURY (Hg) CONTENT	WITH REFERENCE TO IEC 62321 EDITION 1.0: 2008, BY ACID DIGESTION AND DETERMINED BY ICP-OES	2 mg/kg
CHROMIUM (VI) (Cr <sup>6+</sup> ) CONTENT (FOR NON-METAL)	WITH REFERENCE TO IEC 62321 EDITION 1.0: 2008, BY ALKALINE DIGESTION AND DETERMINED BY UV-VIS SPECTROPHOTOMETER	1 mg/kg
POLYBROMINATED BIPHENYLS (PBBs) & POLYBROMINATED DIPHENYL ETHERS (PBDEs)	WITH REFERENCE TO IEC IEC 62321 EDITION 1.0: 2008, BY SOLVENT EXTRACTION AND DETERMINED BY GC/MS AND FURTHER HPLC CONFIRMATION WHEN NECESSARY.	5 mg/kg

DATE SAMPLE RECEIVED:AUG 02, 2010

TESTING PERIOD:AUG 02, 2010 TO AUG 05, 2010

\*\*\*\*\*

TO BE CONTINUED

PAGE 3 OF 5

**Intertek Testing Services Wuxi Ltd.**

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Tel: +86 510 8821 4567 Fax: +86 510 8820 0428 E-mail: consumergoods.wuxi@intertek.com

## Annex 8: Analysis Result of Ceramic Substrate (Page 4 of 5)

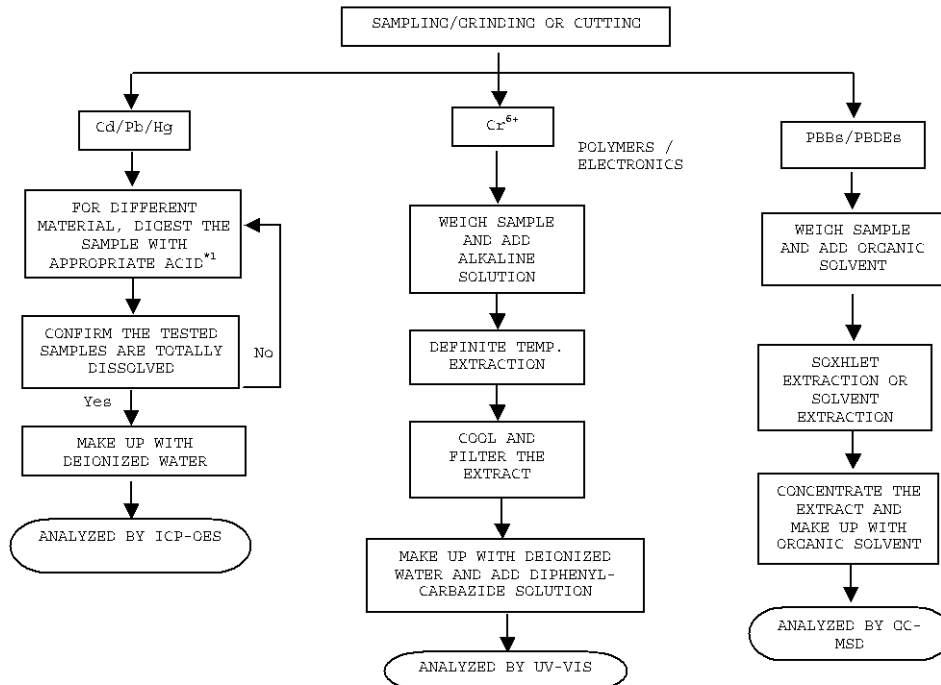


### TEST REPORT

NUMBER: WUXH00002764

#### TESTS CONDUCTED

(D) MEASUREMENT FLOWCHART:  
 TEST FOR Cd/Pb/Hg/Cr (VI)/PBBs/PBDEs CONTENTS  
 REFERENCE STANDARD: IEC 62321 EDITION 1.0: 2008



CHEMIST: INORGANIC (ANN LUO/FRED WANG/ALLY WAN)  
 ORGANIC (JENNY XU/CHERRY SUN)

#### REMARKS:

\*1: LIST OF APPROPRIATE ACID:

MATERIAL	ACID ADDED FOR DIGESTION
POLYMERS	HNO <sub>3</sub> , HCl, HF, H <sub>2</sub> O <sub>2</sub> , H <sub>3</sub> BO <sub>3</sub>
METALS	HNO <sub>3</sub> , HCl, HF
ELECTRONICS	HNO <sub>3</sub> , HCl, H <sub>2</sub> O <sub>2</sub> , HBF <sub>4</sub>

\*2: IF THE RESULT OF SPOT TEST IS POSITIVE, CHROMIUM VI WOULD BE DETERMINED AS DETECTED.

\*\*\*\*\*

TO BE CONTINUED

PAGE 4 OF 5

**Intertek Testing Services Wuxi Ltd.**

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 Wuxi 214101, Jiangsu, China

Tel: +86 510 8821 4567 Fax: +86 510 8820 0428 E-mail: consumergoods.wuxi@intertek.com



## Annex 8: Analysis Result of Ceramic Substrate (Page 5 of 5)

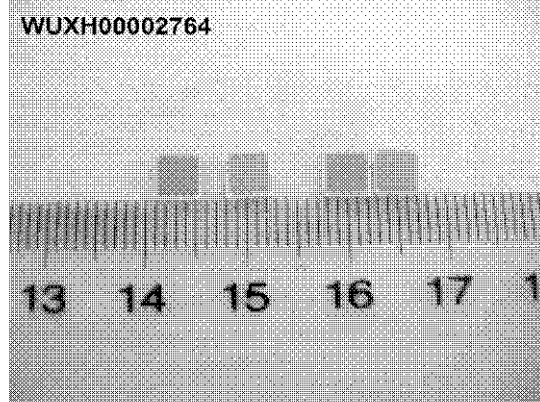


TEST REPORT

NUMBER: WUXH00002764

TESTS CONDUCTED

PHOTO



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END OF REPORT

PAGE 5 OF 5

**Intertek Testing Services Wuxi Ltd.**  
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**Annex 9: Analysis Result of Marking Ink (Page 1 of 7)****TEST REPORT**

NUMBER: WUXH00002762

APPLICANT: CONCORD SEMICONDUCTOR (WUXI) CO., LTD.  
DATE: AUG 06, 2010  
EAST 1#, ZHENFA 6 ROAD, SHUO FANG  
INDUSTRIAL PARK WUXI NATIONAL HIGH-  
TECH DEVELOPMENT ZONE,  
WUXI, JIANGSU, CHINA  
ATTN: ZHANG XIAOPENG

## SAMPLE DESCRIPTION:

ONE (1) PIECE OF SUBMITTED SAMPLE SAID TO BE : **GREY INK.**

ITEM NAME : UV INK.  
VENDOR : BON MARK.  
COMPONENT OR PART NO. : NA.  
TEST ITEM : Pb, Cd, Hg, CrVI, PBB, PBDE, F, Cl, Br, I.

\*\*\*\*\*

## TESTS CONDUCTED:

AS REQUESTED BY THE APPLICANT, FOR DETAILS REFER TO ATTACHED PAGE(S)

\*\*\*\*\*

## SUMMARY:

<u>TESTED SAMPLE</u>	<u>STANDARD</u>	<u>RESULT</u>
SUBMITTED SAMPLE	WITH REFERENCE TO TEST METHOD OF IEC 62321 EDITION 1.0: 2008 AND MAXIMUM CONCENTRATION LIMITS QUOTED FROM ROHS DIRECTIVES 2002/95/EC AND AMENDMENT 2005/618/EC	PASS

\*\*\*\*\*

TO BE CONTINUED

PREPARED AND CHECKED BY:  
FOR INTERTEK TESTING SERVICES WUXI LTD.



JESSICA LU  
GENERAL MANAGER

PAGE 1 OF 7

**Intertek Testing Services Wuxi Ltd.**  
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## Annex 9: Analysis Result of Marking Ink (Page 2 of 7)


**TEST REPORT**

NUMBER: WUXH00002762

## TESTS CONDUCTED

## (A) TEST RESULT SUMMARY:

TESTING ITEM	RESULT
CADMIUM (Cd) CONTENT (mg/kg)	ND
LEAD (Pb) CONTENT (mg/kg)	211
MERCURY (Hg) CONTENT (mg/kg)	ND
CHROMIUM (VI) (Cr <sup>6+</sup> ) CONTENT (mg/kg) (FOR NON-METAL)	ND
POLYBROMINATED BIPHENYLS (PBBs) (mg/kg)	
MONOBROMO BIPHENYLS (MonoBB)	ND
DIBROMO BIPHENYLS (DiBB)	ND
TRIBROMO BIPHENYLS (TriBB)	ND
TETRABROMO BIPHENYLS (TetraBB)	ND
PENTABROMO BIPHENYLS (PentaBB)	ND
HEXABROMO BIPHENYLS (HexaBB)	ND
HEPTABROMO BIPHENYLS (HeptaBB)	ND
OCTABROMO BIPHENYLS (OctaBB)	ND
NONABROMO BIPHENYLS (NonaBB)	ND
DECABROMO BIPHENYL (DecaBB)	ND
POLYBROMINATED DIPHENYL ETHERS (PBDEs) (mg/kg)	
MONOBROMO DIPHENYL ETHERS (MonoBDE)	ND
DIBROMO DIPHENYL ETHERS (DiBDE)	ND
TRIBROMO DIPHENYL ETHERS (TriBDE)	ND
TETRABROMO DIPHENYL ETHERS (TetraBDE)	ND
PENTABROMO DIPHENYL ETHERS (PentaBDE)	ND
HEXABROMO DIPHENYL ETHERS (HexaBDE)	ND
HEPTABROMO DIPHENYL ETHERS (HeptaBDE)	ND
OCTABROMO DIPHENYL ETHERS (OctaBDE)	ND
NONABROMO DIPHENYL ETHERS (NonaBDE)	ND
DECABROMO DIPHENYL ETHER (DecaBDE)	ND

## REMARK:

mg/kg = MILLIGRAM PER KILOGRAM BASED ON DRY WEIGHT= ppm

ND = NOT DETECTED

\*\*\*\*\*

TO BE CONTINUED

PAGE 2 OF 7

**Intertek Testing Services Wuxi Ltd.**

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## Annex 9: Analysis Result of Marking Ink (Page 3 of 7)


**TEST REPORT**

NUMBER: WUXH00002762

## TESTS CONDUCTED

## (B) RoHS REQUIREMENT:

RESTRICTED SUBSTANCES	LIMITS
CADMIUM (Cd)	0.01% (100 mg/kg)
LEAD (Pb)	0.1% (1000 mg/kg)
MERCURY (Hg)	0.1% (1000 mg/kg)
CHROMIUM (VI) (Cr <sup>6+</sup> )	0.1% (1000 mg/kg)
POLYBROMINATED BIPHENYLS (PBBs)	0.1% (1000 mg/kg)
POLYBROMINATED DIPHENYL ETHERS (PBDEs)	0.1% (1000 mg/kg)

THE ABOVE LIMITS WERE QUOTED FROM 2002/95/EC AND AMENDMENT 2005/618/EC FOR HOMOGENEOUS MATERIAL.

## (c) TEST METHOD:

TESTING ITEM	TESTING METHOD	REPORTING LIMIT
CADMIUM (Cd) CONTENT	WITH REFERENCE TO IEC 62321 EDITION 1.0: 2008, BY ACID DIGESTION AND DETERMINED BY ICP-OES	2 mg/kg
LEAD (Pb) CONTENT	WITH REFERENCE TO IEC 62321 EDITION 1.0: 2008, BY ACID DIGESTION AND DETERMINED BY ICP-OES	2 mg/kg
MERCURY (Hg) CONTENT	WITH REFERENCE TO IEC 62321 EDITION 1.0: 2008, BY ACID DIGESTION AND DETERMINED BY ICP-OES	2 mg/kg
CHROMIUM (VI) (Cr <sup>6+</sup> ) CONTENT (FOR NON-METAL)	WITH REFERENCE TO IEC 62321 EDITION 1.0: 2008, BY ALKALINE DIGESTION AND DETERMINED BY UV-VIS SPECTROPHOTOMETER	1 mg/kg
POLYBROMINATED BIPHENYLS (PBBs) & POLYBROMINATED DIPHENYL ETHERS (PBDEs)	WITH REFERENCE TO IEC IEC 62321 EDITION 1.0: 2008, BY SOLVENT EXTRACTION AND DETERMINED BY GC/MS AND FURTHER HPLC CONFIRMATION WHEN NECESSARY.	5 mg/kg

DATE SAMPLE RECEIVED:AUG 02, 2010

TESTING PERIOD:AUG 02, 2010 TO AUG 05, 2010

\*\*\*\*\*

TO BE CONTINUED

PAGE 3 OF 7

**Intertek Testing Services Wuxi Ltd.**

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## Annex 9: Analysis Result of Marking Ink (Page 4 of 7)

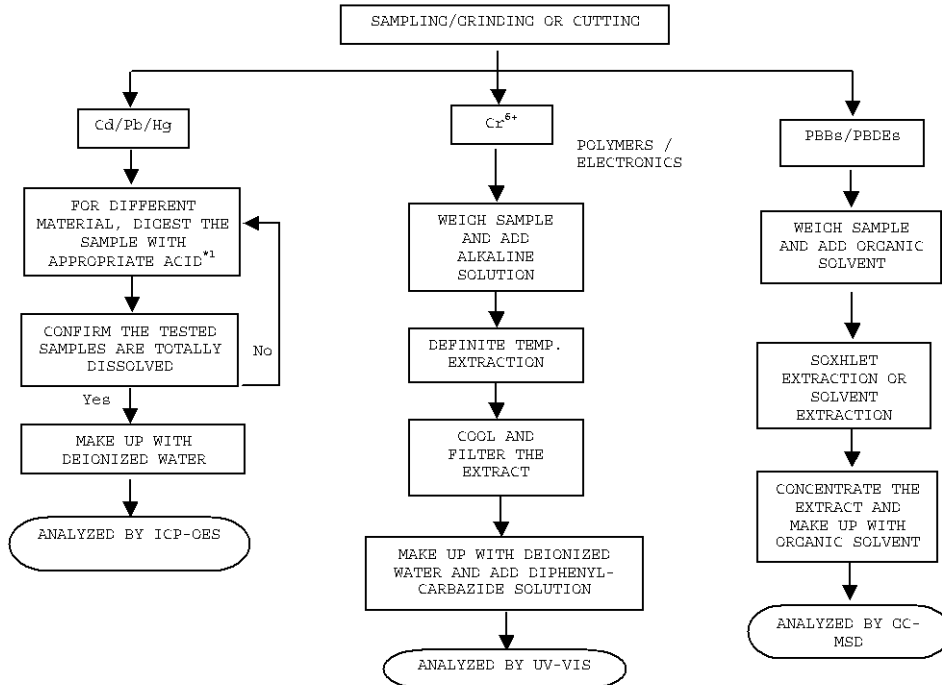
**Intertek**

**TEST REPORT**

NUMBER: WUXH00002762

TESTS CONDUCTED

(D) MEASUREMENT FLOWCHART:  
 TEST FOR Cd/Pb/Hg/Cr (VI)/PBBs/PBDEs CONTENTS  
 REFERENCE STANDARD: IEC 62321 EDITION 1.0: 2008



CHEMIST: INORGANIC (ANN LUO/FRED WANG/ALLY WAN)  
 ORGANIC (JENNY XU/CHERRY SUN)

REMARKS:

\*1: LIST OF APPROPRIATE ACID:

MATERIAL	ACID ADDED FOR DIGESTION
POLYMERS	HNO <sub>3</sub> , HCl, HF, H <sub>2</sub> O <sub>2</sub> , H <sub>3</sub> BO <sub>3</sub>
METALS	HNO <sub>3</sub> , HCl, HF
ELECTRONICS	HNO <sub>3</sub> , HCl, H <sub>2</sub> O <sub>2</sub> , HBF <sub>4</sub>

\*2: IF THE RESULT OF SPOT TEST IS POSITIVE, CHROMIUM VI WOULD BE DETERMINED AS DETECTED.

\*\*\*\*\*

TO BE CONTINUED

## Annex 9: Analysis Result of Marking Ink (Page 5 of 7)


**TEST REPORT**

NUMBER: WUXH00002762

## TESTS CONDUCTED

## (I) TEST RESULT SUMMARY :

## HALOGEN CONTENT :

TESTING ITEM	RESULT (ppm)
FLUORINE (F) CONTENT	ND
CHLORINE (Cl) CONTENT	112
BROMINE (Br) CONTENT	ND
IODINE (I) CONTENT	ND

REMARKS : ppm = PARTS PER MILLION = mg/kg

ND = NOT DETECTED

DATE SAMPLE RECEIVE: AUG 02, 2010

TEST PERIOD: AUG 02, 2010 TO AUG 05, 2010

## (II) TEST METHOD :

TESTING ITEM	TESTING METHOD	REPORTING LIMIT
HALOGEN (F, Cl, Br, I) CONTENT	WITH REFERENCE TO IEC 61189-2:2006 BY COMBUSTION FLASK AND DETERMINED BY ION CHROMATOGRAPHY	50 ppm

REMARKS : REPORTING LIMIT = QUANTITATION LIMIT OF ANALYTE IN SAMPLE

\*\*\*\*\*

TO BE CONTINUED

PAGE 5 OF 7

**Intertek Testing Services Wuxi Ltd.**

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**Annex 9: Analysis Result of Marking Ink (Page 6 of 7)**



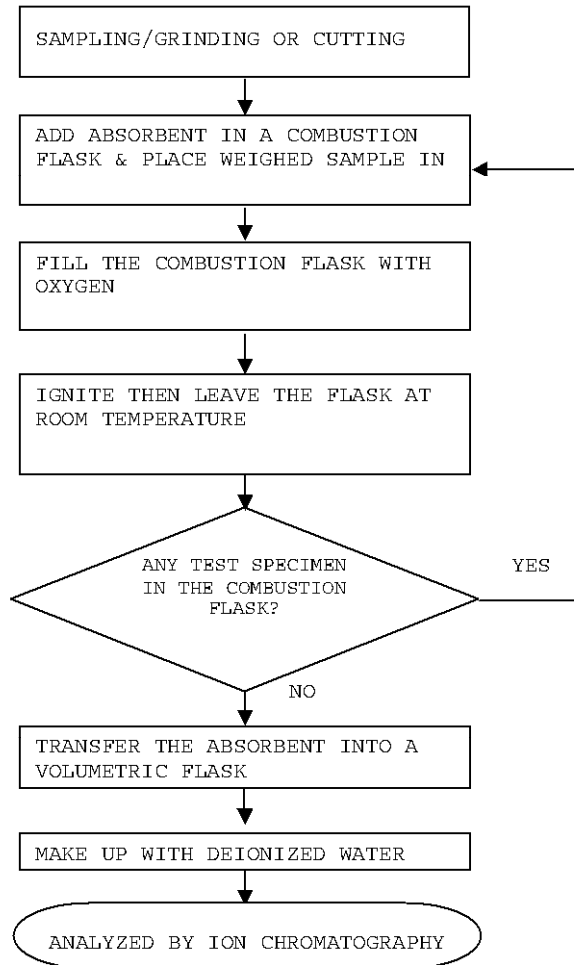
**TEST REPORT**

NUMBER: WUXH00002762

TESTS CONDUCTED

(III) MEASUREMENT FLOWCHART:

TEST FOR HALOGEN CONTENT  
REFERENCE METHOD: IEC 61189-2 TEST 2C12



CHEMIST: FRED WANG/ ALLY WAN

\*\*\*\*\*

TO BE CONTINUED

**Annex 9: Analysis Result of Marking Ink (Page 7 of 7)**

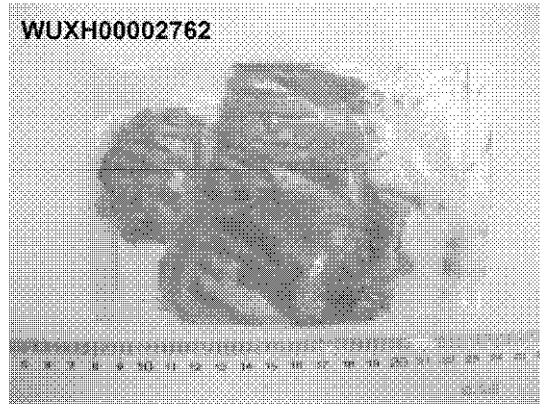


TEST REPORT

NUMBER: WUXH00002762

TESTS CONDUCTED

PHOTO



\*\*\*\*\*  
END OF REPORT

PAGE 7 OF 7

**Intertek Testing Services Wuxi Ltd.**  
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## Annex 10: Applicable RoHS exemptions

13.2.2003	EN	Official Journal of the European Union	L 37/19
<b>DIRECTIVE 2002/95/EC OF THE EUROPEAN PARLIAMENT AND OF THE COUNCIL</b> <b>of 27 January 2003</b> <b>on the restriction of the use of certain hazardous substances in electrical and electronic equipment</b>			

13.2.2003	EN	Official Journal of
Article 4  <b>Prevention</b>		
1. Member States shall ensure that, from 1 July 2006, new electrical and electronic equipment put on the market does not contain lead, mercury, cadmium, hexavalent chromium, polybrominated biphenyls (PBB) or polybrominated diphenyl ethers (PBDE). National measures restricting or prohibiting the use of these substances in electrical and electronic equipment which were adopted in line with Community legislation before the adoption of this Directive may be maintained until 1 July 2006.		

to be protected and an overall strategy that in particular restricts the use of cadmium and stimulates research into substitutes should therefore be implemented. The Reso-

13.2.2003	EN	Official Journal of the European Union	L 37/23
2. Paragraph 1 shall not apply to the applications listed in the Annex.			

### ANNEX

#### Applications of lead, mercury, cadmium and hexavalent chromium, which are exempted from the requirements of Article 4(1)

1. Mercury in compact fluorescent lamps not exceeding 5 mg per lamp.
2. Mercury in straight fluorescent lamps for general purposes not exceeding:
 

— halophosphate	10 mg
— triphosphate with normal lifetime	5 mg
— triphosphate with long lifetime	8 mg.
3. Mercury in straight fluorescent lamps for special purposes.
4. Mercury in other lamps not specifically mentioned in this Annex.
5. Lead in glass of cathode ray tubes, electronic components and fluorescent tubes.
6. Lead as an alloying element in steel containing up to 0,35 % lead by weight, aluminium containing up to 0,4 % lead by weight and as a copper alloy containing up to 4 % lead by weight.
7. — Lead in high melting temperature type solders (i.e. tin-lead solder alloys containing more than 85 % lead),
  - lead in solders for servers, storage and storage array systems (exemption granted until 2010),
  - lead in solders for network infrastructure equipment for switching, signalling, transmission as well as network management for telecommunication,
  - lead in electronic ceramic parts (e.g. piezoelectronic devices).
8. Cadmium plating except for applications banned under Directive 91/338/EEC (\*) amending Directive 76/769/EEC (\*\*) relating to restrictions on the marketing and use of certain dangerous substances and preparations.